



CETECOM ICT Services is now

CTC | **advanced**
member of RWTÜV group

TEST REPORT

Test report no.: 1-3129/16-01-10



Deutsche
Akkreditierungsstelle
D-PL-12076-01-01

Testing laboratory

CTC advanced GmbH

Untertuerkheimer Strasse 6 – 10
66117 Saarbruecken / Germany
Phone: + 49 681 5 98 - 0
Fax: + 49 681 5 98 - 9075
Internet: <http://www.ctcadvanced.com>
e-mail: mail@ctcadvanced.com

Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAKKS). The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01.

Applicant

Sonova AG

Laubisruestrasse 28
8712 Staefa / SWITZERLAND
Phone: +41 5 89 28 01 01
Fax: +41 5 89 28 20 11
Contact: Valentina Shcherba
e-mail: valentina.shcherba@sonova.com
Phone: +41 5 89 28 01 01

Manufacturer

Sonova AG

Laubisruestrasse 28
8712 Staefa / SWITZERLAND

Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 4	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	Wireless Hearing Instrument
Model name:	Phonak Audéo B90-Direct
FCC ID:	KWC-BTD1
IC:	2262A-BTD1
Frequency:	DTS band 2400 MHz to 2483.5 MHz
Technology tested:	Bluetooth® (basic rate)
Antenna:	Integrated antenna
Power supply:	1.25 V DC by Zinc - Air battery
Temperature range:	0°C to +40°C



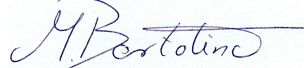
This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:


cn=Stefan Böes, o=CTC advanced GmbH,
ou=BOE-161129,
email=Stefan.Boes@ctcadvanced.com, c=DE
2017.04.20 08:21:24 +02'00'

Stefan Böes
Lab Manager
Radio Communications & EMC

Test performed:


cn=Marco Bertolino, o=CTC advanced GmbH,
ou=BTL-161128,
email=Marco.Bertolino@ctcadvanced.com, c=DE
2017.04.20 07:37:15 +02'00'

Marco Bertolino
Lab Manager
Radio Communications & EMC

1 Table of contents

1	Table of contents.....	2
2	General information	3
2.1	Notes and disclaimer	3
2.2	Application details	3
2.3	Test laboratories sub-contracted	3
3	Test standard/s and references.....	4
4	Test environment	5
5	Test item	5
5.1	General description.....	5
5.2	Additional information	5
6	Description of the test setup	6
6.1	Shielded semi anechoic chamber	7
6.2	Shielded fully anechoic chamber	8
6.3	Radiated measurements > 18 GHz	9
6.4	Conducted measurements C.BER system	10
7	Sequence of testing	11
7.1	Sequence of testing radiated spurious 9 kHz to 30 MHz	11
7.2	Sequence of testing radiated spurious 30 MHz to 1 GHz	12
7.3	Sequence of testing radiated spurious 1 GHz to 18 GHz	13
7.4	Sequence of testing radiated spurious above 18 GHz	14
8	Measurement uncertainty.....	15
9	Summary of measurement results	16
10	Additional comments.....	17
11	Measurement results	18
11.1	Antenna gain.....	18
11.2	Carrier frequency separation	19
11.3	Number of hopping channels	21
11.4	Time of occupancy (dwell time)	23
11.5	Spectrum bandwidth of a FHSS system.....	24
11.6	Maximum output power	27
11.7	Detailed spurious emissions @ the band edge - conducted	30
11.8	Band edge compliance radiated	33
11.9	Spurious emissions conducted	36
11.10	Spurious emissions radiated below 30 MHz	40
11.11	Spurious emissions radiated 30 MHz to 1 GHz	43
11.12	Spurious emissions radiated above 1 GHz	48
12	Observations	54
Annex A	Document history	54
Annex B	Further information.....	54
Annex C	Accreditation Certificate	55

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CTC advanced GmbH.

The testing service provided by CTC advanced GmbH has been rendered under the current "General Terms and Conditions for CTC advanced GmbH".

CTC advanced GmbH will not be liable for any loss or damage resulting from false, inaccurate, inappropriate or incomplete product information provided by the customer.

Under no circumstances does the CTC advanced GmbH test report include any endorsement or warranty regarding the functionality, quality or performance of any other product or service provided.

Under no circumstances does the CTC advanced GmbH test report include or imply any product or service warranties from CTC advanced GmbH, including, without limitation, any implied warranties of merchantability, fitness for purpose, or non-infringement, all of which are expressly disclaimed by CTC advanced GmbH.

All rights and remedies regarding vendor's products and services for which CTC advanced GmbH has prepared this test report shall be provided by the party offering such products or services and not by CTC advanced GmbH. In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2017-02-02
Date of receipt of test item:	2017-03-08
Start of test:	2017-03-08
End of test:	2017-03-15
Person(s) present during the test:	-/-

2.3 Test laboratories sub-contracted

None

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15	-/-	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	February 2017	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	:	T _{nom} T _{max} T _{min}	+23 °C during room temperature tests No tests under extreme temperature conditions required! No tests under extreme temperature conditions required!
Relative humidity content	:		35 %
Barometric pressure	:		1019 hpa
Power supply	:	V _{nom} V _{max} V _{min}	1.25 V DC by Zinc - Air battery No tests under extreme voltage conditions required! No tests under extreme voltage conditions required!

5 Test item

5.1 General description

Kind of test item	:	Wireless Hearing Instrument
Type identification	:	Phonak Audéo B90-Direct
Series / additional variants	:	Phonak Audéo B70-Direct Phonak Audéo B50-Direct Selectic Luna R9-C Selectic Luna R7-C
HMN	:	-/-
PMN	:	Phonak Audéo B-Direct
HVIN	:	Phonak Audéo B90-Direct Phonak Audéo B70-Direct Phonak Audéo B50-Direct
FVIN	:	-/-
S/N serial number	:	Radiated unit: sample 57 Conducted unit: sample 54 Photos: sample 52 (external)
HW hardware status	:	050-0279
SW software status	:	Target 5.2 Beta 1 / RF test software
FW firmware status	:	067-1243
Frequency band	:	DTS band 2400 MHz to 2483.5 MHz (lowest channel 2402 MHz; highest channel 2480 MHz)
Type of radio transmission	:	FHSS
Use of frequency spectrum	:	
Type of modulation	:	GFSK
Number of channels	:	79
Antenna	:	Integrated antenna
Power supply	:	1.25 V DC by Zinc - Air battery
Temperature range	:	0°C to +40°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-3129/16-01-01_AnnexA
 1-3129/16-01-01_AnnexB*
 1-3129/16-01-01_AnnexD

* Internal photos provided by the customer.

6 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

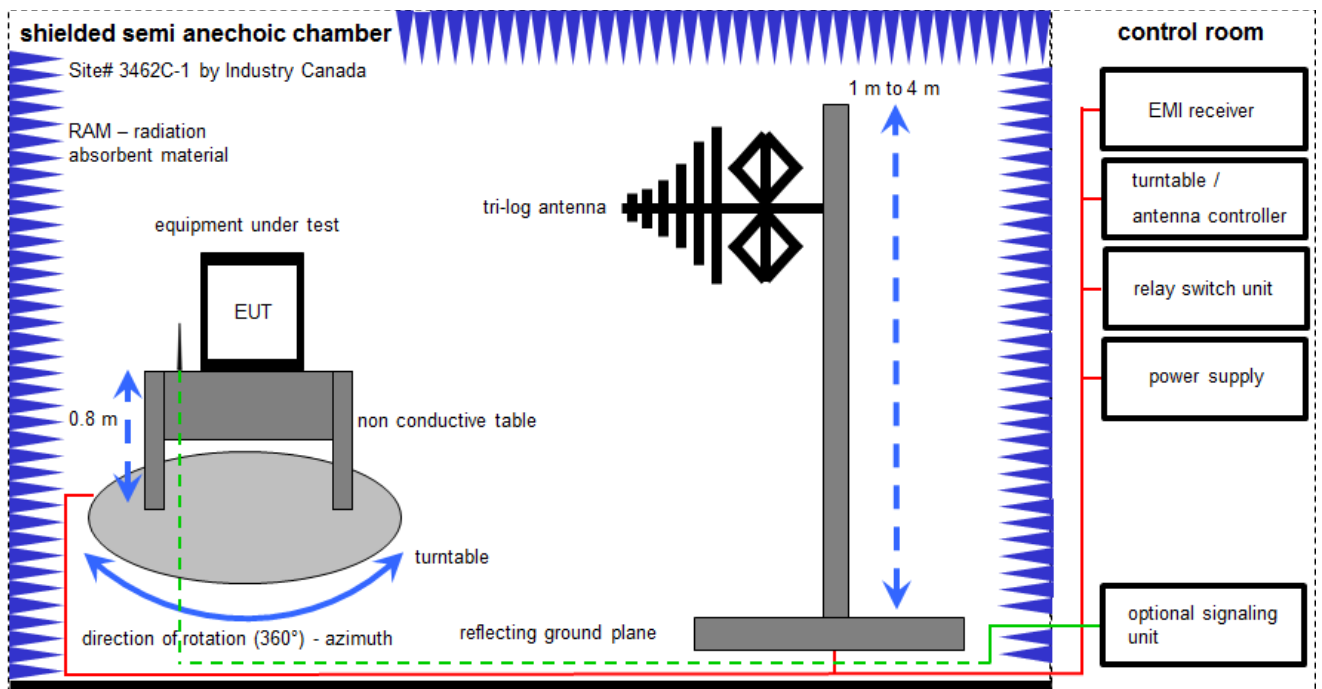
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vk!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

6.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are conform to specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

$$FS = UR + CL + AF$$

(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

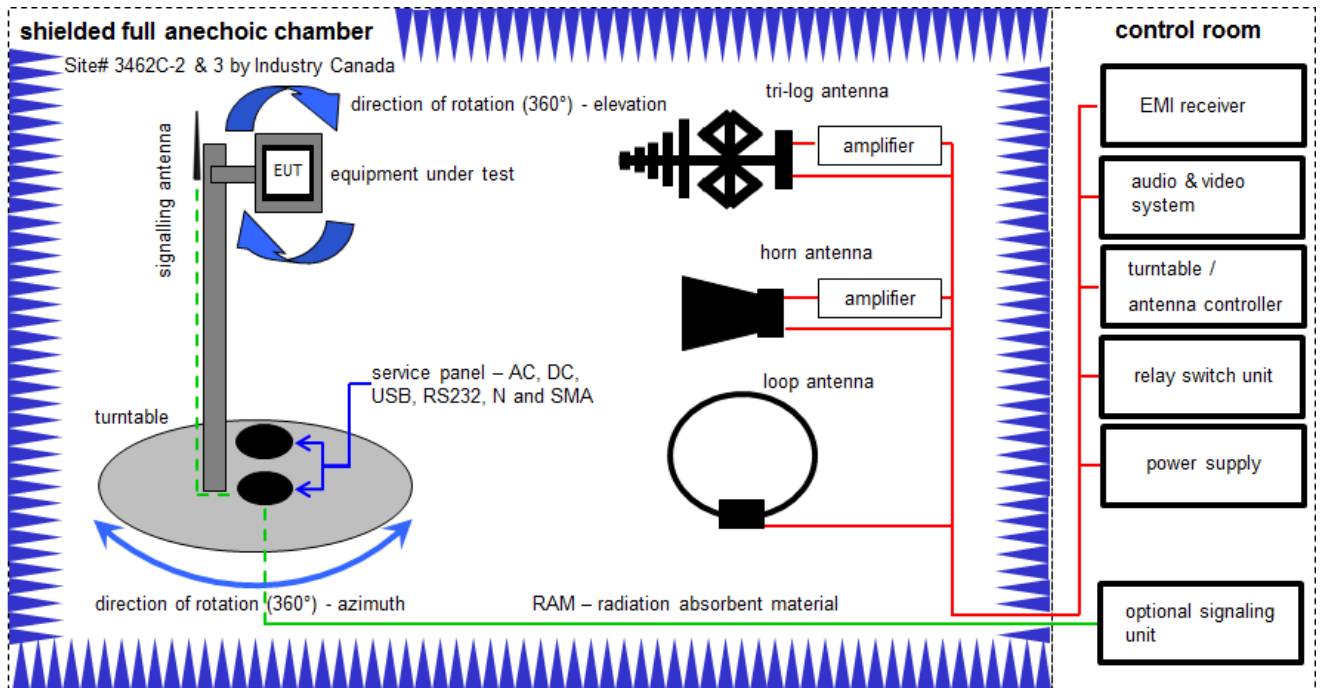
Example calculation:

$$FS [dB\mu V/m] = 12.35 [dB\mu V/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dB\mu V/m] (35.69 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Meßkabine 1	HF-Absorberhalle	MWB AG 300023		300000551	ne	-/-	-/-
2	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	01.02.2017	31.01.2018
3	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
4	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
5	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
6	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	25.04.2016	25.04.2018
7	A	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.2 Shielded fully anechoic chamber



Measurement distance: tri-log antenna and horn antenna 3 meter; loop antenna 3 meter / 1 meter

FS = UR + CA + AF

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

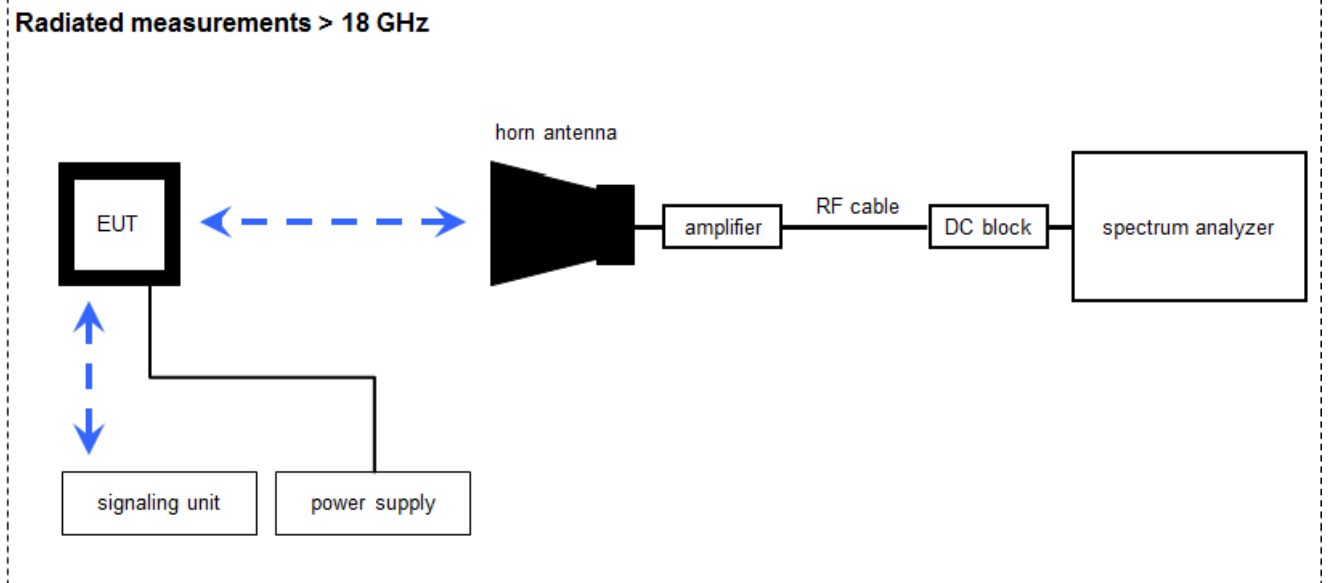
Example calculation:

FS [dBμV/m] = 40.0 [dBμV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBμV/m] (71.61 μV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	C	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO	2210	300001015	k	20.05.2015	20.05.2017
2	A, B	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	9709-5290	300000212	k	13.08.2015	13.08.2017
3	B	Highpass Filter	WHK1.1/15G-10SS	Wainwright	37	400000148	ne	-/-	-/-
4	B	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
5	B	Band Reject Filter	WRCG2400/2483-2375/2505-50/10SS	Wainwright	26	300003792	ne	-/-	-/-
6	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000032	300004510	ne	-/-	-/-
7	A, B, C	Computer	Intel Core i3 3220/3,3 GHz, Prozessor	-/-	2V2403033A54 21	300004591	ne	-/-	-/-
8	A, B, C	NEXIO EMV-Software	BAT EMC V3.16.0.49	EMCO	-/-	300004682	ne	-/-	-/-
9	A, B, C	Anechoic chamber		TDK	-/-	300003726	ne	-/-	-/-
10	A, B, C	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	vIKI!	13.09.2016	13.03.2018
11	B	RF Amplifier	AFS4-00100800-28-20P-4-R	MITEQ	2008992	300005204	ne	-/-	-/-
12	B	RF-Amplifier	AMF-6F06001800-30-10P-R	NARDA-MITEQ Inc	2011571	300005240	ev	-/-	-/-
13	A, B, C	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
14	A, B, C	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.3 Radiated measurements > 18 GHz



Measurement distance: horn antenna 50 cm

$$FS = U_R + CA + AF$$

(FS-field strength; U_R -voltage at the receiver; CA-loss signal path & distance correction; AF-antenna factor)

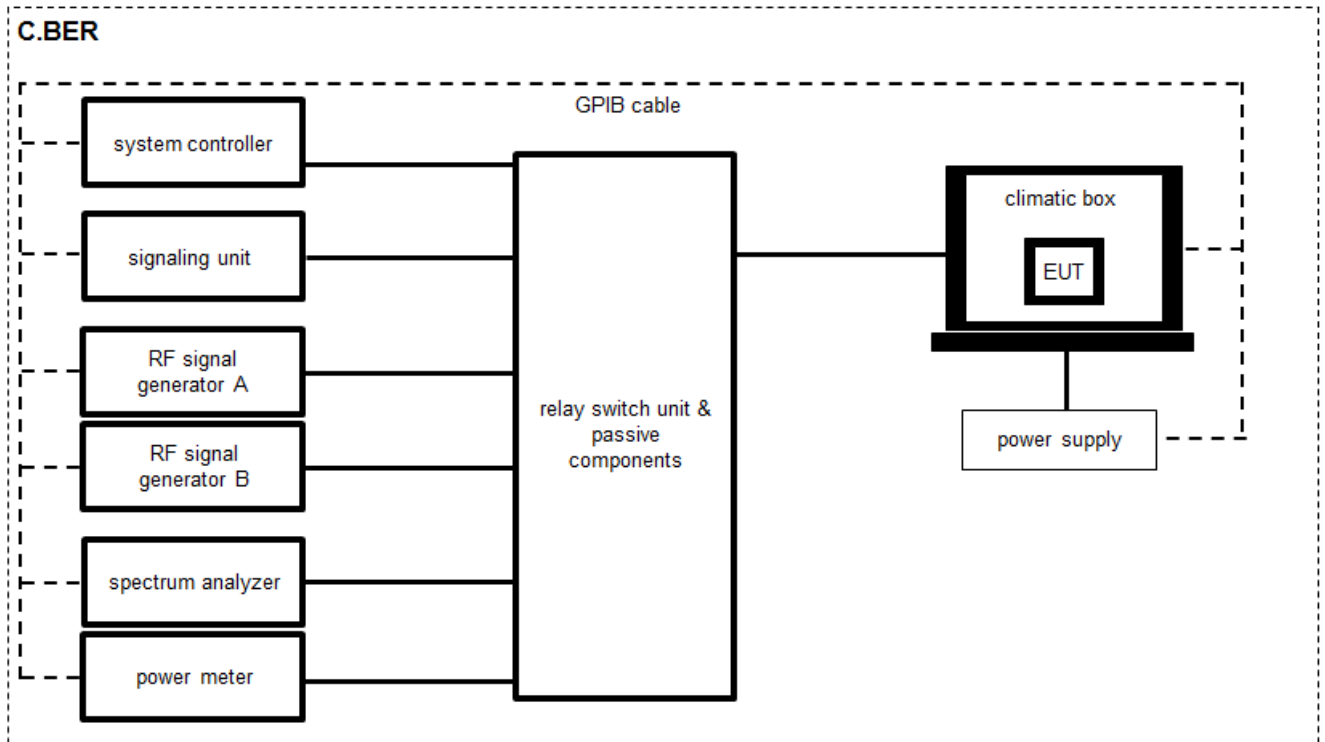
Example calculation:

$$FS \text{ [dB}\mu\text{V/m]} = 40.0 \text{ [dB}\mu\text{V/m]} + (-60.1) \text{ [dB]} + 36.74 \text{ [dB/m]} = 16.64 \text{ [dB}\mu\text{V/m]} \text{ (6.79 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	-/-	300000486	k	10.09.2015	10.09.2017
2	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	27.01.2017	26.01.2018
3	A	Amplifier 2-40 GHz	JS32-02004000-57-5P	MITEQ	1777200	300004541	ev	-/-	-/-
4	A	RF-Cable	ST18/SMAM/SMAM/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
5	A	RF-Cable	ST18/SMAM/SMAM/48	Huber & Suhner	Batch no. 127377	400001183	ev	-/-	-/-
6	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	-/-	400001185	ev	-/-	-/-
7	A	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.4 Conducted measurements C.BER system



OP = AV + CA
 (OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:

OP [dBm] = 6.0 [dBm] + 11.7 [dB] = 17.7 [dBm] (58.88 mW)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch / Control Unit	3488A	HP	-/-	300000929	ne	-/-	-/-
2	A	CBT (Bluetooth Tester + EDR Signalling)	CBT 1153.9000K35	R&S	100185	300003416	vIKI!	10.02.2017	09.02.2019
3	A	USB/GPIB interface	82357B	Agilent Technologies	MY52103346	300004390	ne	-/-	-/-
4	A	Signal Analyzer 30GHz	FSV30	R&S	103170	300004855	k	30.01.2017	29.01.2019
5	A	DC-Blocker	8143	Inmet Corp.	none	300002842	ne	-/-	-/-
6	A	Powersplitter	6005-3	Inmet Corp.	-/-	300002841	ev	-/-	-/-
7	A	Messplatzrechner	Tecline	F+W	-/-	300003580	ne	-/-	-/-
8	A	RF-Cable	ST18/SMAm/SMAm/72	Huber & Suhner	Batch no. 605505	400001187	ev	-/-	-/-
9	A	RF-Cable	Sucoflex 104	Huber & Suhner	147636/4	400001188	ev	-/-	-/-
10	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 699866	400001189	ev	-/-	-/-
11	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 14844	400001190	ev	-/-	-/-

7 Sequence of testing

7.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

7.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position $\pm 45^\circ$ and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

7.3 Sequence of testing radiated spurious 1 GHz to 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

7.4 Sequence of testing radiated spurious above 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

8 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Carrier frequency separation	± 21.5 kHz
Number of hopping channels	-/-
Time of occupancy	According BT Core specification
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

9 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS - 247, Issue 2	See table!	2017-04-20	-/-

Test specification clause	Test case	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4) RSS - 247 / 5.4 (b)	Antenna gain	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(a)(1) RSS - 247 / 5.1 (b)	Carrier frequency separation	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(a)(1) RSS - 247 / 5.1 (d)	Number of hopping channels	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(a)(1) (iii) RSS - 247 / 5.1 (d)	Time of occupancy (dwell time)	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(a)(1) RSS - 247 / 5.1 (a)	Spectrum bandwidth of a FHSS system bandwidth	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(b)(1) RSS - 247 / 5.4 (b)	Maximum output power	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5	Detailed spurious emissions @ the band edge - conducted	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance radiated	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5	Spurious emissions conducted	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.209(a) RSS - Gen	Spurious emissions radiated below 30 MHz	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated 30 MHz to 1 GHz	Nominal	Nominal	GFSK RX mode	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated above 1 GHz	Nominal	Nominal	GFSK RX mode	☒	☐	☐	☐	-/-
§15.107(a) §15.207	Conducted emissions below 30 MHz (AC conducted)	Nominal	Nominal	GFSK RX mode	☐	☐	☒	☐	Battery powered only!-

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

10 Additional comments

The Bluetooth® word mark and logos are owned by the Bluetooth SIG Inc. and any use of such marks by CTC advanced GmbH is under license.

Reference documents: Customer Questionnaire 1-3129-16-1 (3)

Special test descriptions: None

Configuration descriptions: TX tests: were performed with x-DH5 packets and static PRBS pattern payload.
 RX/Standby tests: BT test mode enabled, scan enabled, TX Idle

Test mode:

☒ Bluetooth Test mode loop back enabled
 (EUT is controlled over CBT/CMU/CMW)

☐ Special software is used.
 EUT is transmitting pseudo random data by itself

Antennas and transmit operating modes:

☒ Operating mode 1 (single antenna)

- Equipment with 1 antenna,
- Equipment with 2 diversity antennas operating in switched diversity mode by which at any moment in time only 1 antenna is used,
- Smart antenna system with 2 or more transmit/receive chains, but operating in a mode where only 1 transmit/receive chain is used)

11 Measurement results

11.1 Antenna gain

Measurement:

The antenna gain of the complete system is calculated by the difference of radiated power in EIRP and the conducted power of the module. For normal Bluetooth® devices, the GFSK modulation is used.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	3 MHz
Span	5 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 B (radiated) See sub clause 6.4 A (conducted)
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
6 dBi / > 6 dBi output power and power density reduction required	

Results:

T _{nom}	V _{nom}	lowest channel 2402 MHz	middle channel 2441 MHz	highest channel 2480 MHz
Conducted power [dBm] Measured with GFSK modulation		-0.4	-1.4	-0.8
Radiated power [dBm] Measured with GFSK modulation		-12.1	-9.5	-11.4
Gain [dBi] Calculated		-11.7	-8.1	-10.6

11.2 Carrier frequency separation

Description:

Measurement of the carrier frequency separation of a hopping system. The carrier frequency separation is constant for all modulation-modes. We use GFSK-modulation to show compliance. EUT in hopping mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	4 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

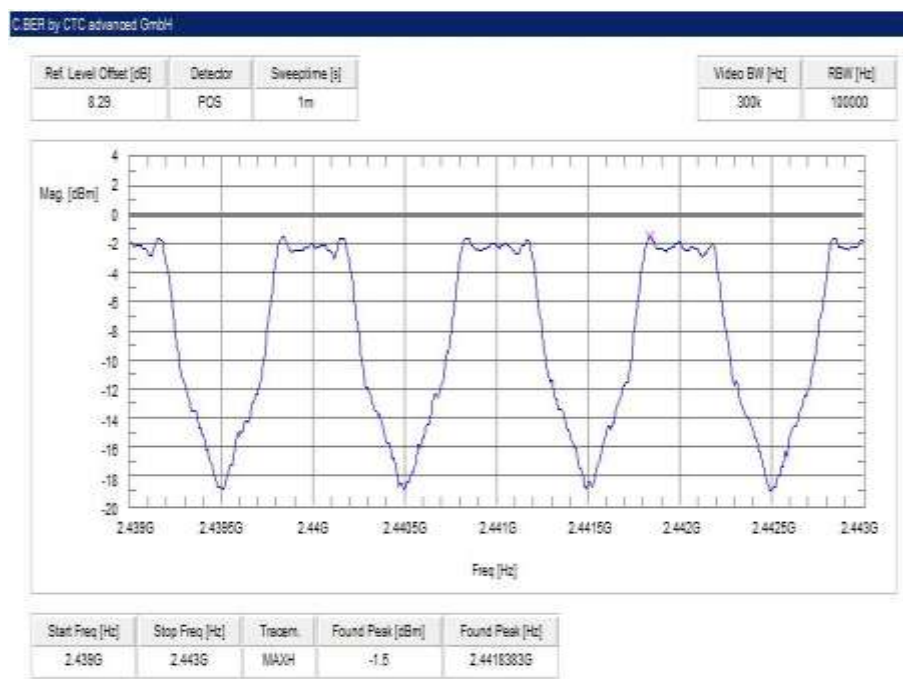
FCC	IC
Carrier frequency separation	
Minimum 25 kHz or two-thirds of the 20 dB bandwidth of the hopping system whichever is greater.	

Result:

Carrier frequency separation	~ 1 MHz
------------------------------	---------

Plot:

Plot 1: Carrier frequency separation (GFSK modulation)



11.3 Number of hopping channels

Description:

Measurement of the total number of used hopping channels. The number of hopping channels is constant for all modulation-modes. We use GFSK-modulation to show compliance. EUT in hopping mode.

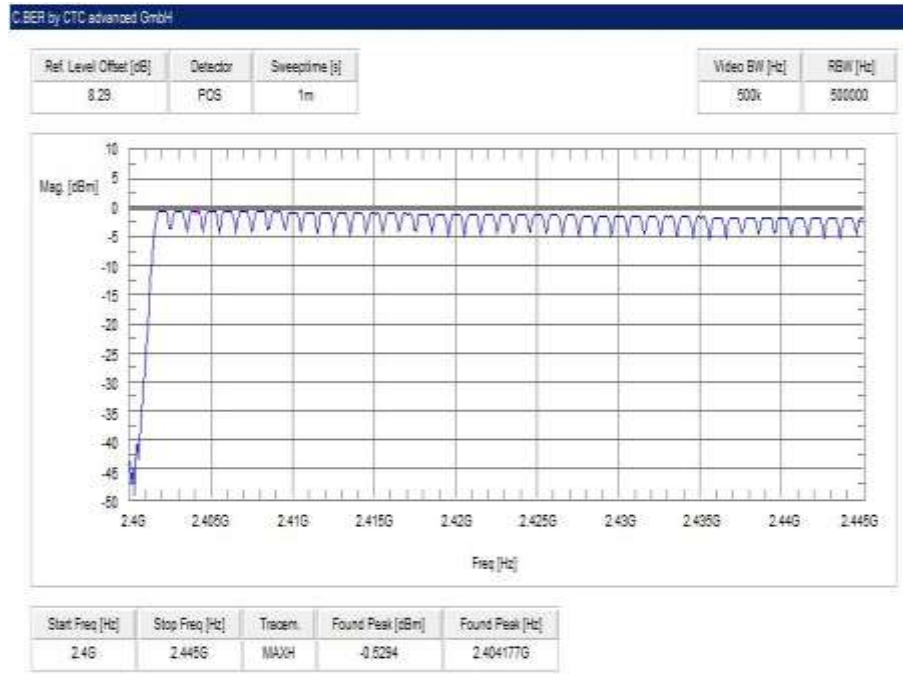
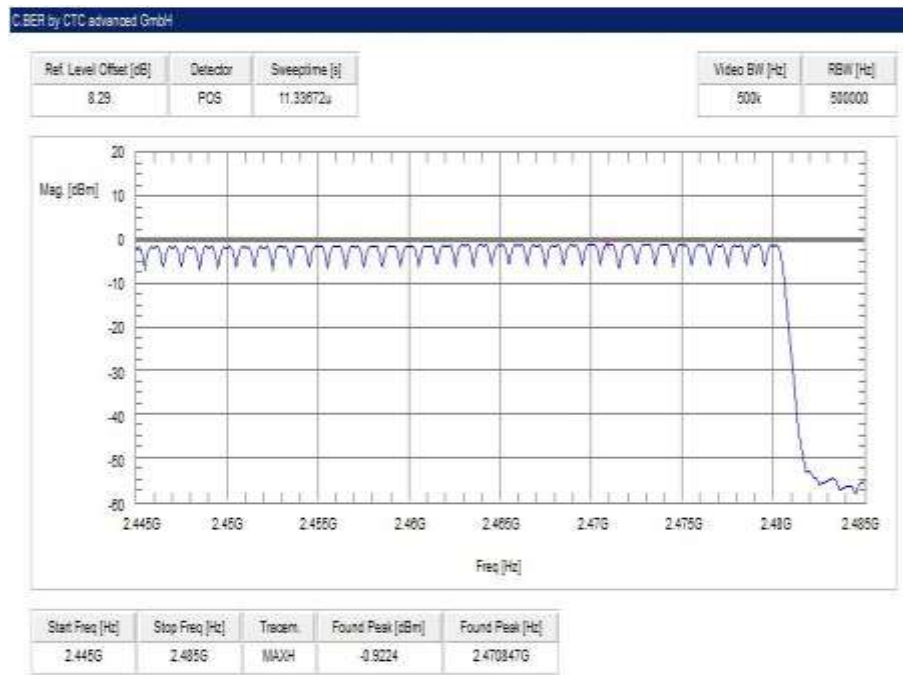
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	500 kHz
Video bandwidth	500 kHz
Span	Plot 1: 2400 – 2445 MHz Plot 2: 2445 – 2485 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Number of hopping channels	
At least 15 non overlapping hopping channels	

Result:

Number of hopping channels	79
----------------------------	----

Plots:**Plot 1:** Number of hopping channels (GFSK modulation)**Plot 2:** Number of hopping channels (GFSK modulation)

11.4 Time of occupancy (dwell time)

Measurement:

For Bluetooth® devices no measurements mandatory depending on the fixed requirements according to the Bluetooth® Core Specifications!

For Bluetooth® devices:

The channel staying time of 0.4 s within a 31.6 second period in data mode is constant for Bluetooth® devices and independent from the packet type (packet length). The calculation for a 31.6 second period is as follows:

Channel staying time = time slot length * hop rate / number of hopping channels * 31.6 s

Example for a DH1 packet (with a maximum length of one time slot)
 Channel staying time = $625 \mu\text{s} * 1600 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s}$ (in a 31.6 s period)

For multi-slot packets the hopping is reduced according to the length of the packet.

Example for a DH3 packet (with a maximum length of three time slots)
 Channel staying time = $3 * 625 \mu\text{s} * 1600/3 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s}$ (in a 31.6 s period)

Example for a DH5 packet (with a maximum length of five time slots)
 Channel staying time = $5 * 625 \mu\text{s} * 1600/5 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s}$ (in a 31.6 s period)

This is according to the Bluetooth® Core Specification V2.0 & V2.1 & V3.0 & V4.0 (+ critical errata) for all Bluetooth® devices and all modulations.

The following table shows the relations:

Packet Size	Pulse Width [ms] *	Max. number of transmissions per channel in 31.6 sec
DH1	0.366	640
DH3	1.622	214
DH5	2.870	128

* according Bluetooth® specification

Results:

Packet Size	Pulse Width [ms]*	Max. number of transmissions in 31.6 sec	Dwell time [Pulse width * Number of transmissions]
DH1	0.366	640	234.2 ms
DH3	1.622	214	347.1 ms
DH5	2.870	128	367.4 ms

Limits:

FCC	IC
Time of occupancy (dwell time)	
The frequency hopping operation shall have an average time of occupancy on any frequency not exceeding 0.4 seconds within a duration in seconds equal to the number of hopping frequencies multiplied by 0.4.	

11.5 Spectrum bandwidth of a FHSS system

Description:

Measurement of the 20dB bandwidth and 99% bandwidth of the modulated signal. The measurement is performed according to the "Measurement Guidelines" (DA 00-705, March 30, 2000). EUT in single channel mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	30 kHz
Video bandwidth	100 kHz
Span	3 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Spectrum bandwidth of a FHSS system	
GFSK < 1500 kHz Pi/4 DQPSK < 1500 kHz 8DPSK < 1500 kHz	

Results:

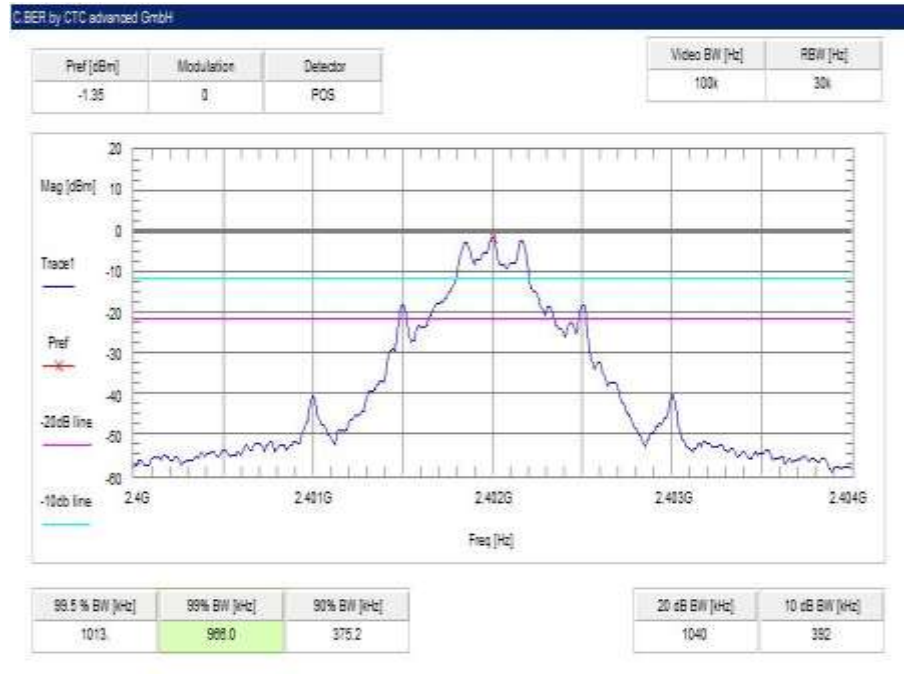
Modulation Frequency	20 dB bandwidth [kHz]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	1040	1032	1040

Results:

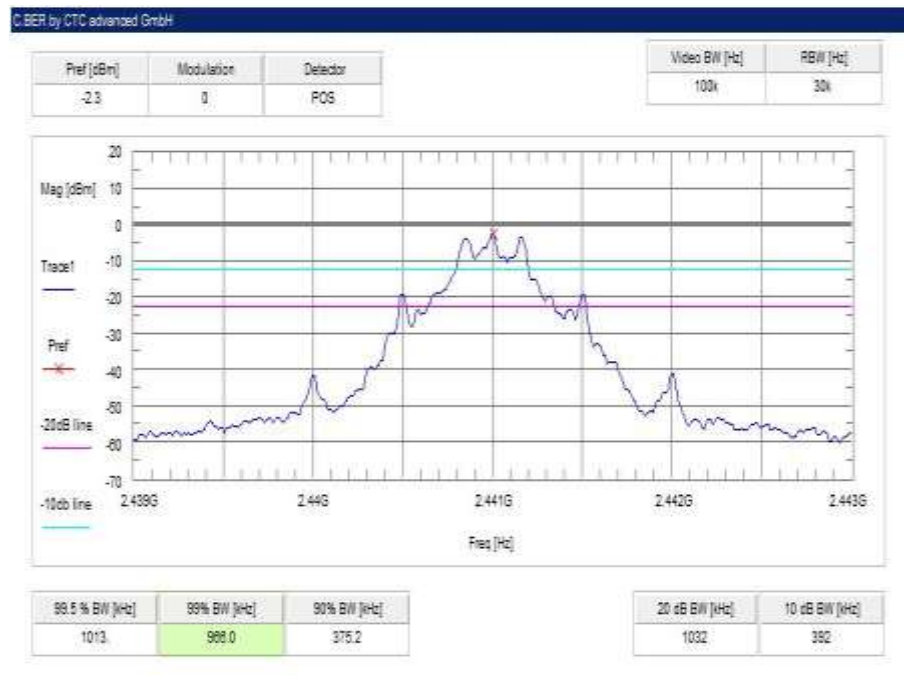
Modulation Frequency	99 % bandwidth [kHz]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	966	966	958

Plots:

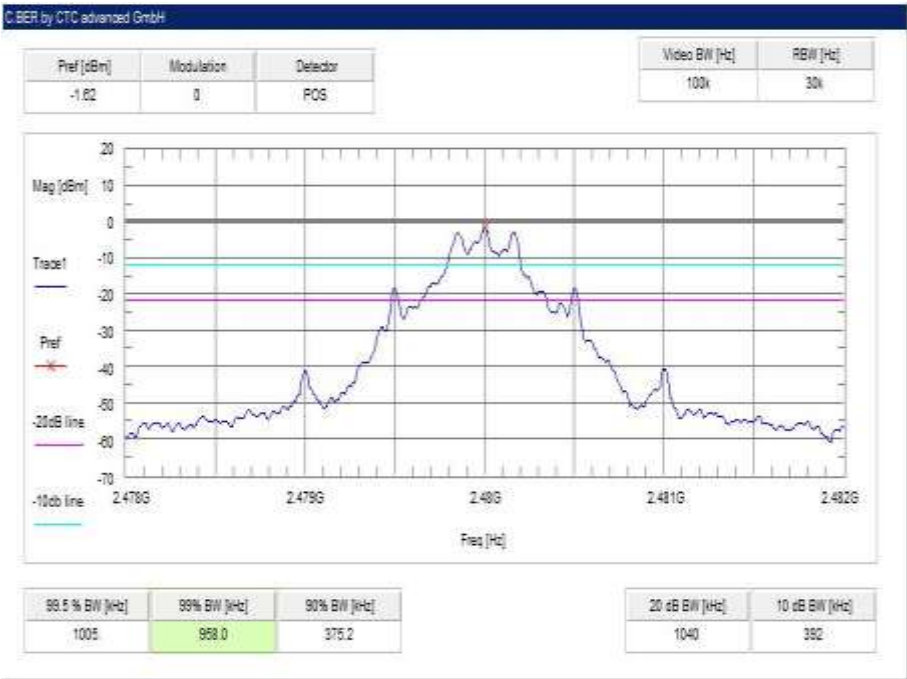
Plot 1: lowest channel – 2402 MHz, GFSK modulation



Plot 2: middle channel – 2441 MHz, GFSK modulation



Plot 3: high channel – 2480 MHz, GFSK modulation



11.6 Maximum output power

Description:

Measurement of the maximum output power conducted and radiated. EUT in single channel mode. The measurement is performed according to the ANSI C63.10.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	10 MHz
Span	6 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Maximum output power	
[Conducted: 0.125 W – antenna gain max. 6 dBi] Systems using more than 75 hopping channels: Conducted: 1.0 W – antenna gain max. 6 dBi	

Results:

Modulation Frequency	Maximum output power conducted [dBm]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	-0.4	-1.4	-0.8

Plots:

Plot 1: lowest channel – 2402 MHz, GFSK modulation



Plot 2: middle channel – 2441 MHz, GFSK modulation



Plot 3: highest channel – 2480 MHz, GFSK modulation



11.7 Detailed spurious emissions @ the band edge - conducted

Description:

Measurement of the conducted band edge compliance. EUT is measured at the lower and upper band edge in single channel and hopping mode. The measurement is repeated for all modulations.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz / 500 kHz
Span	Lower Band Edge: 2395 – 2405 MHz Upper Band Edge: 2478 – 2489 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

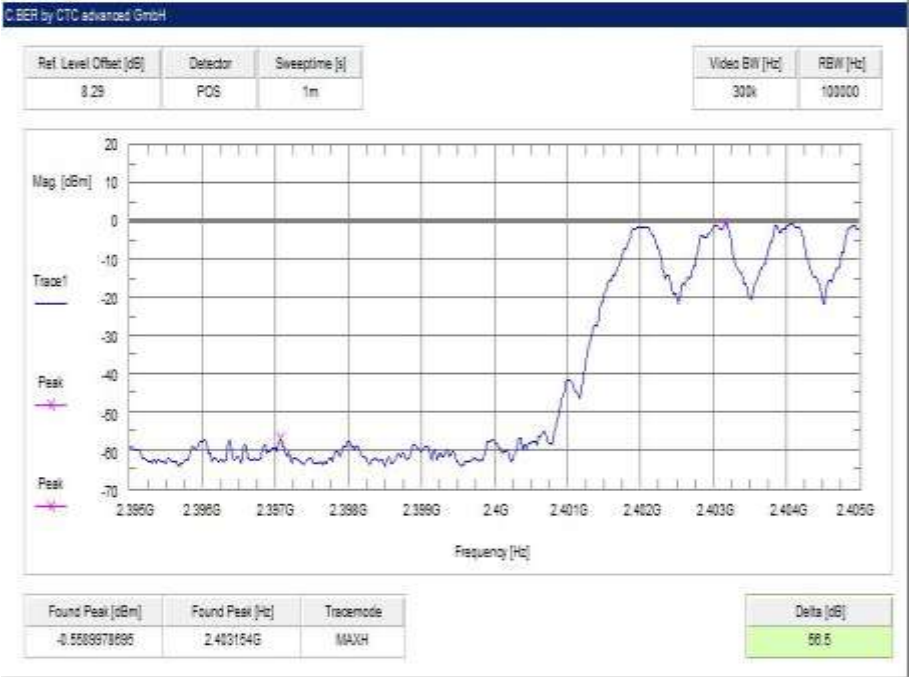
FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.	

Results:

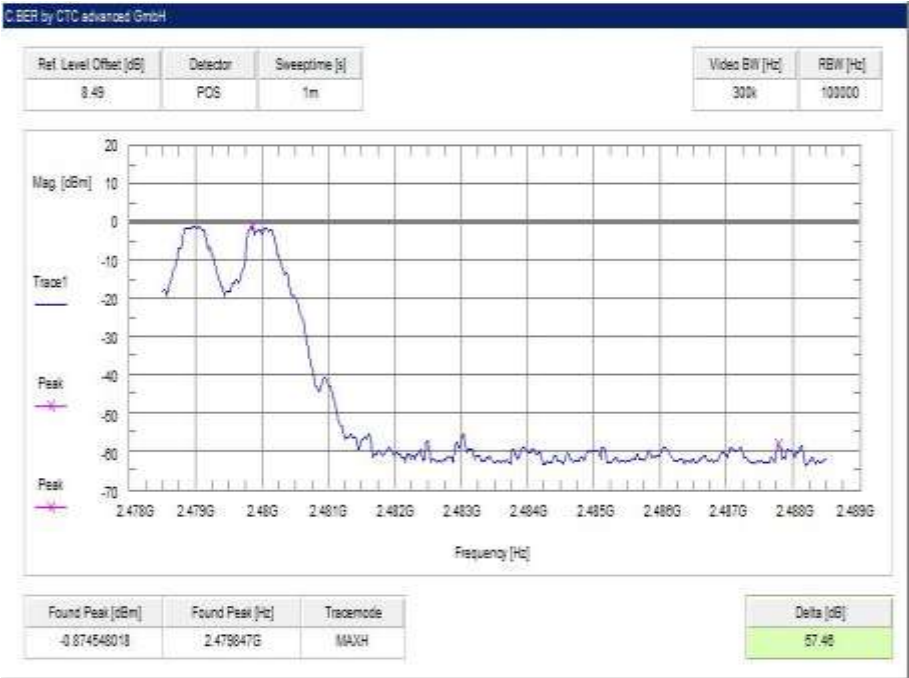
Scenario Modulation	Spurious band edge conducted [dB]		
	GFSK	Pi/4 DQPSK	8DPSK
Lower band edge – hopping off	> 20 dB	-/-	-/-
Lower band edge – hopping on	> 20 dB	-/-	-/-
Upper band edge – hopping off	> 20 dB	-/-	-/-
Upper band edge – hopping on	> 20 dB	-/-	-/-

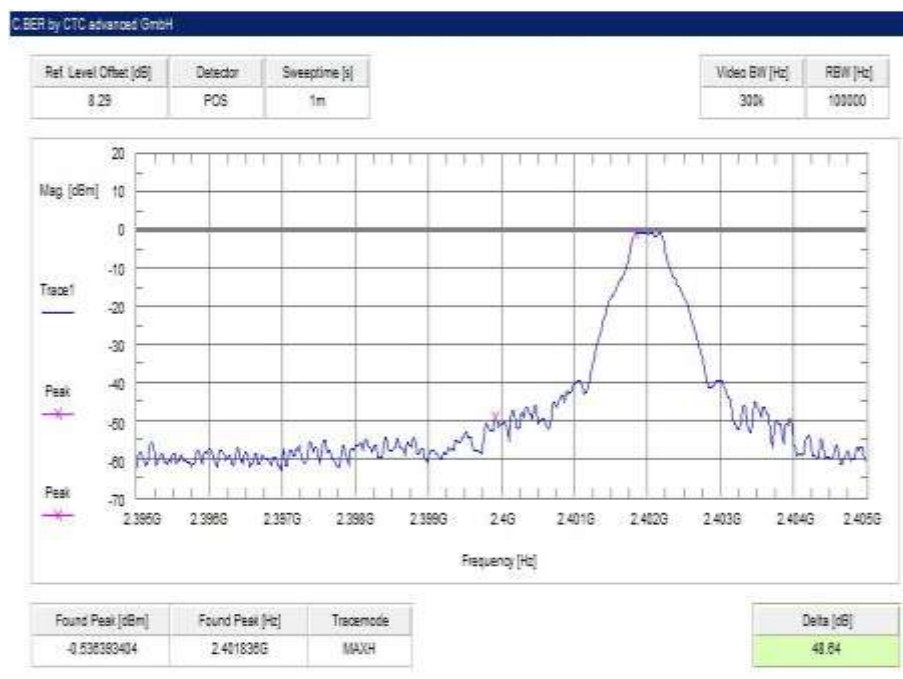
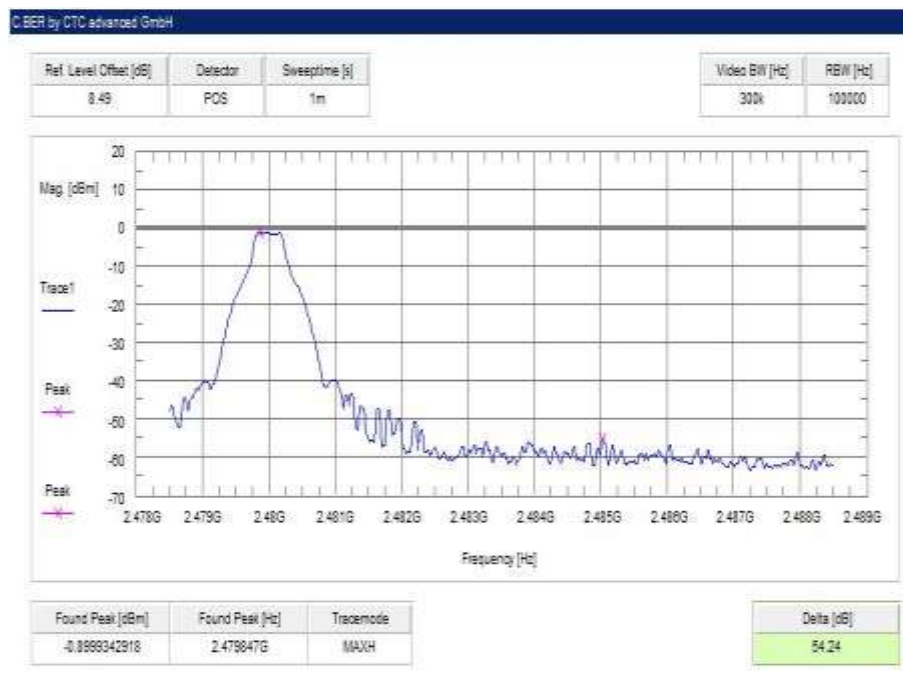
Plots:

Plot 1: Lower band edge – hopping on, GFSK modulation



Plot 2: Upper band edge – hopping on, GFSK modulation



Plot 3: Lower band edge – hopping off, GFSK modulation**Plot 4:** Upper band edge – hopping off, GFSK modulation

11.8 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to single channel mode and the transmit channel is channel 00 for the lower restricted band and channel 78 for the upper restricted band. The measurement is repeated for all modulations. Measurement distance is 3m.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 MHz
Span	Lower Band: 2370 – 2400 MHz Upper Band: 2480 – 2500 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 B
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Band edge compliance radiated	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).	
54 dBµV/m AVG 74 dBµV/m Peak	

Results:

Scenario Modulation	Band edge compliance radiated [dBµV/m]		
	GFSK	Pi/4 DQPSK	8DPSK
Lower restricted band	53.7 (peak) 23.6 (average)*	-/-	-/-
Upper restricted band	51.1 (peak) 21.0 (average)*	-/-	-/-

*) Average emission adjusting factor:

$$F = 20 * \log (\text{dwell time} / 100 \text{ ms})$$

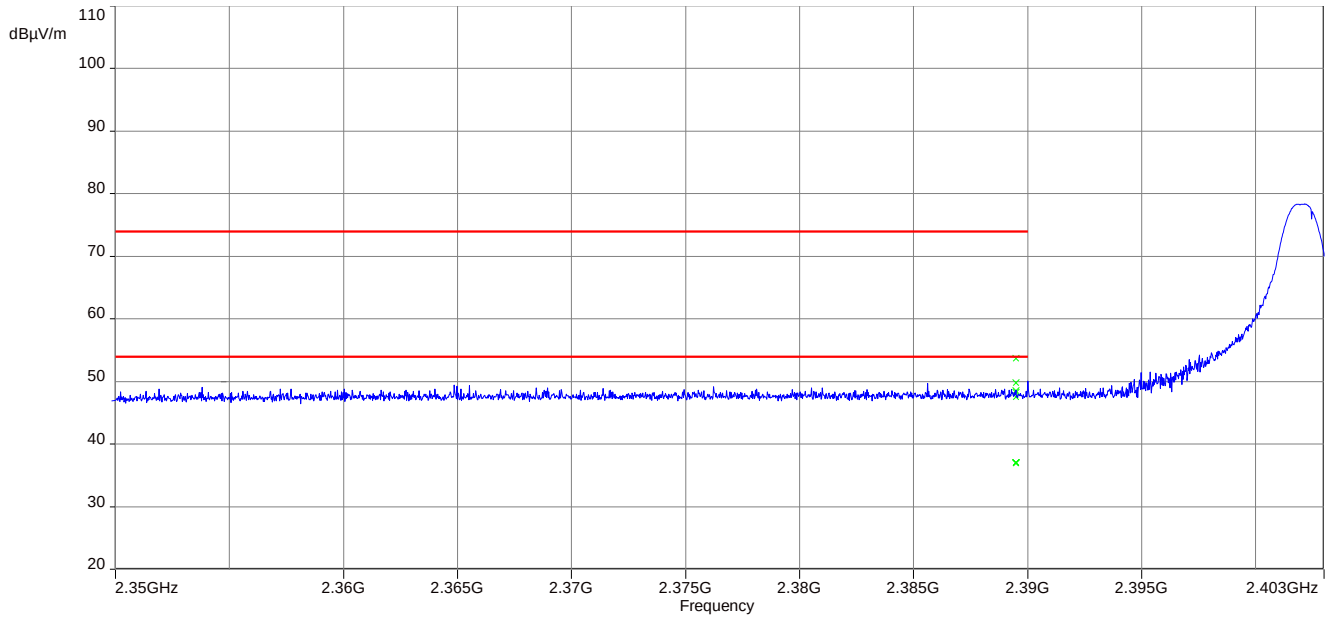
The dwell time of the longest possible Bluetooth transmission (DH5-packet) is 3.125 ms.

In a period of 100 ms, we have a maximum of 1 transmission and that implies a correction factor for spurious measurement emissions:

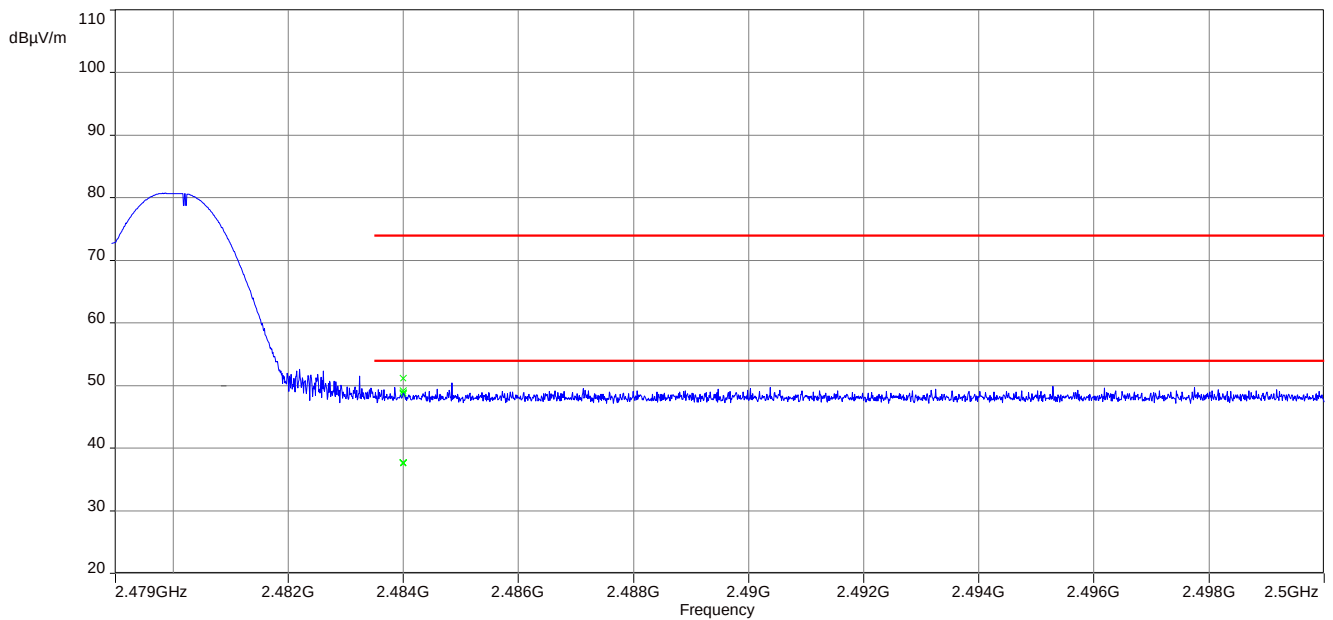
$$F = 20 * \log (1 * 3.125 / 100) = -30.1 \text{ dB}$$

Plots:

Plot 1: Lower band edge, GFSK modulation, vertical & horizontal polarization



Plot 2: Upper band edge, GFSK modulation, vertical & horizontal polarization



11.9 Spurious emissions conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is repeated for all modulations.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	9 kHz to 26 GHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

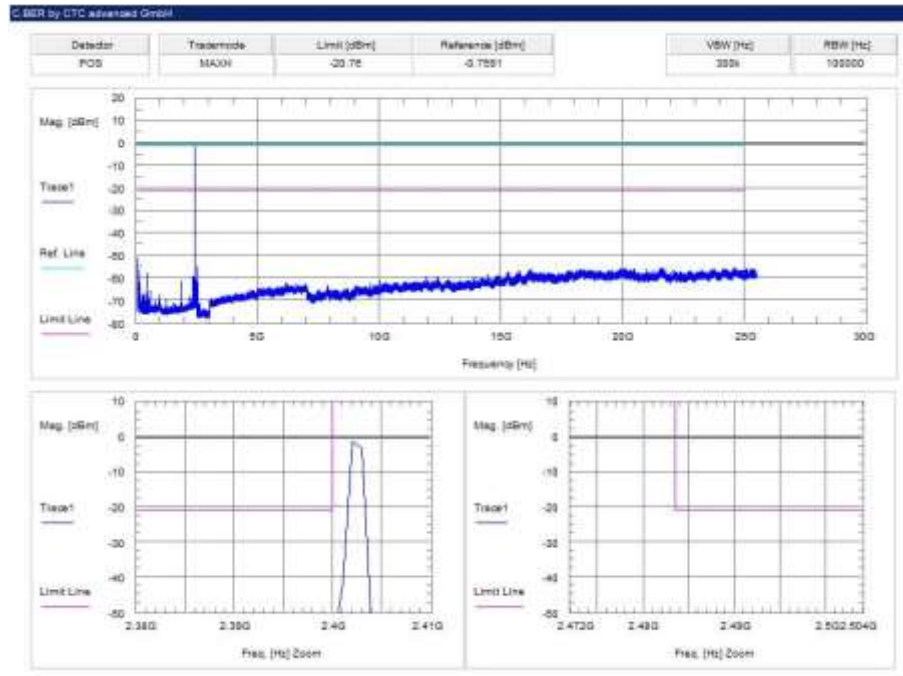
FCC	IC
TX spurious emissions conducted	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	

Results:

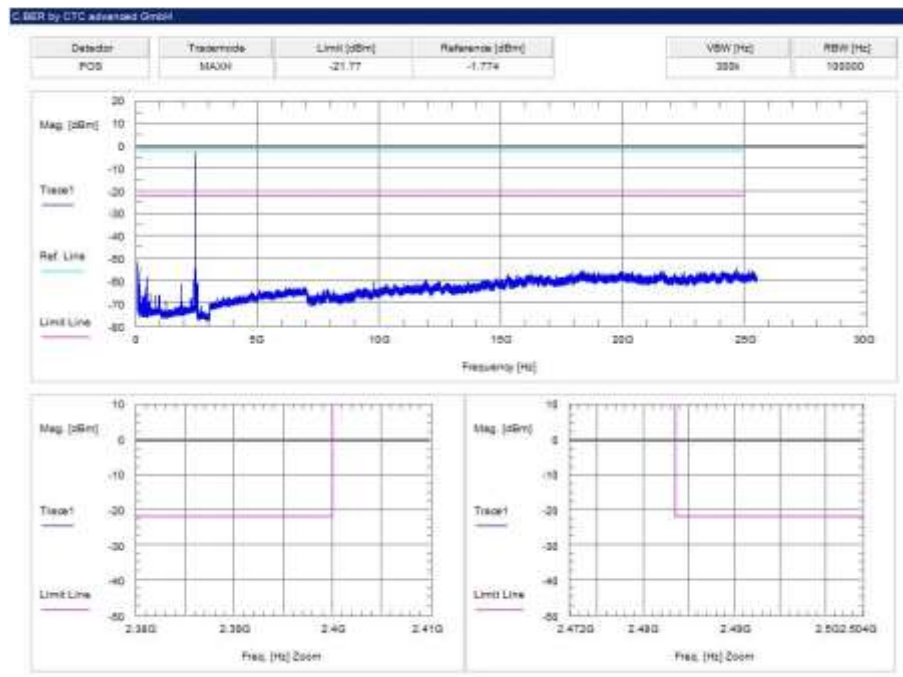
TX spurious emissions conducted					
GFSK - mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2402		-0.8	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2441		-1.8	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2480		-1.0	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant

Plots:

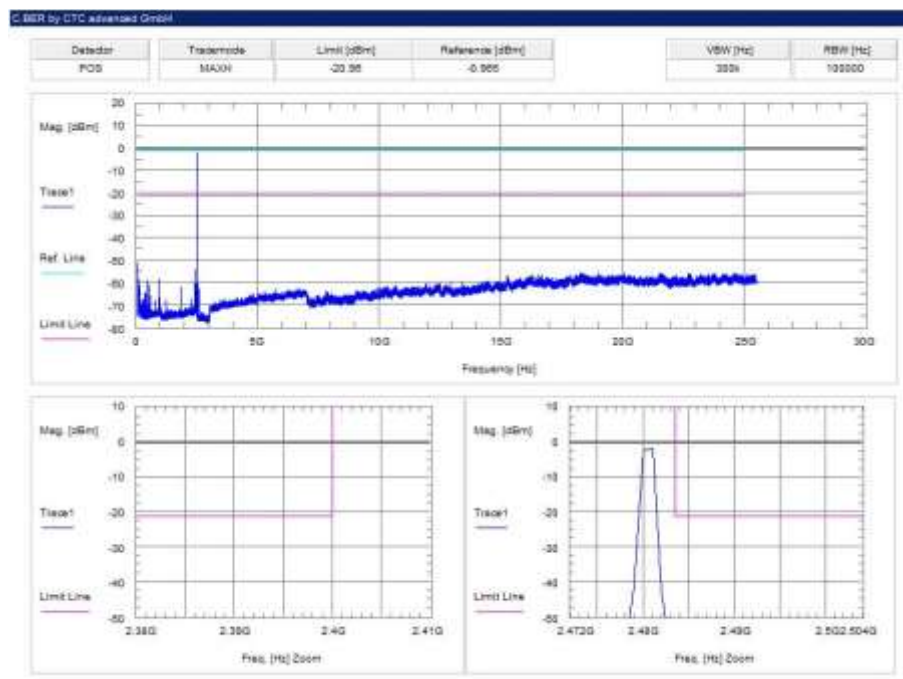
Plot 1: lowest channel – 2402 MHz, GFSK modulation



Plot 2: middle channel – 2441 MHz, GFSK modulation



Plot 3: highest channel – 2480 MHz, GFSK modulation



11.10 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channels are 00; 39 and 78. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement parameters	
Detector	Peak / Quasi peak
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span	9 kHz to 30 MHz
Measured modulation	☒ GFSK ☐ Pi/4 DQPSK ☐ 8DPSK
Trace mode	Max hold
Test setup	See sub clause 6.2 C
Measurement uncertainty	See sub clause 8

Limits:

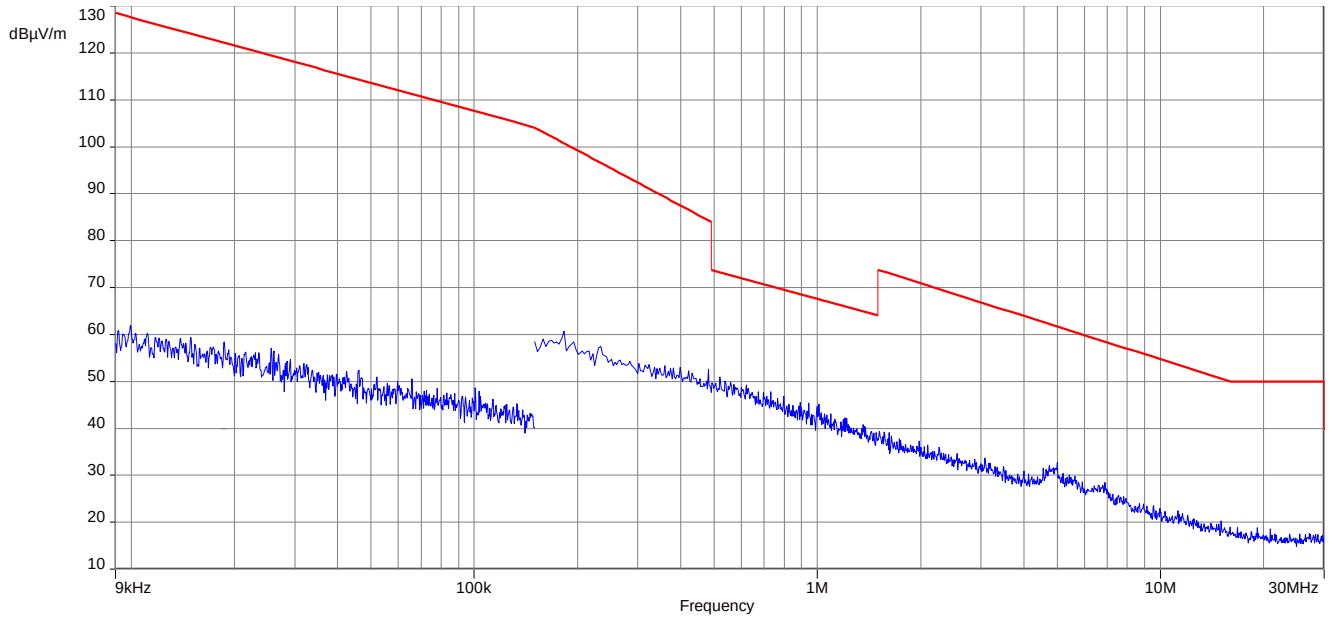
FCC		IC
TX spurious emissions radiated below 30 MHz		
Frequency (MHz)	Field strength (dBμV/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

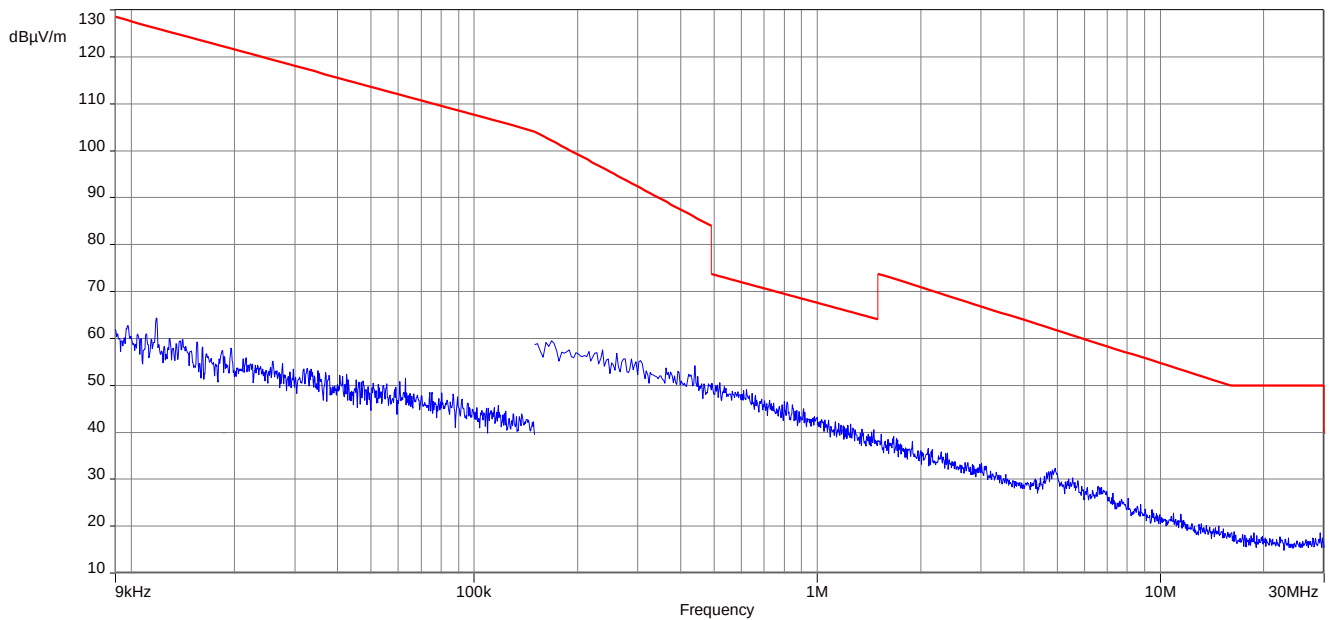
TX spurious emissions radiated below 30 MHz [dBμV/m]		
F [MHz]	Detector	Level [dBμV/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

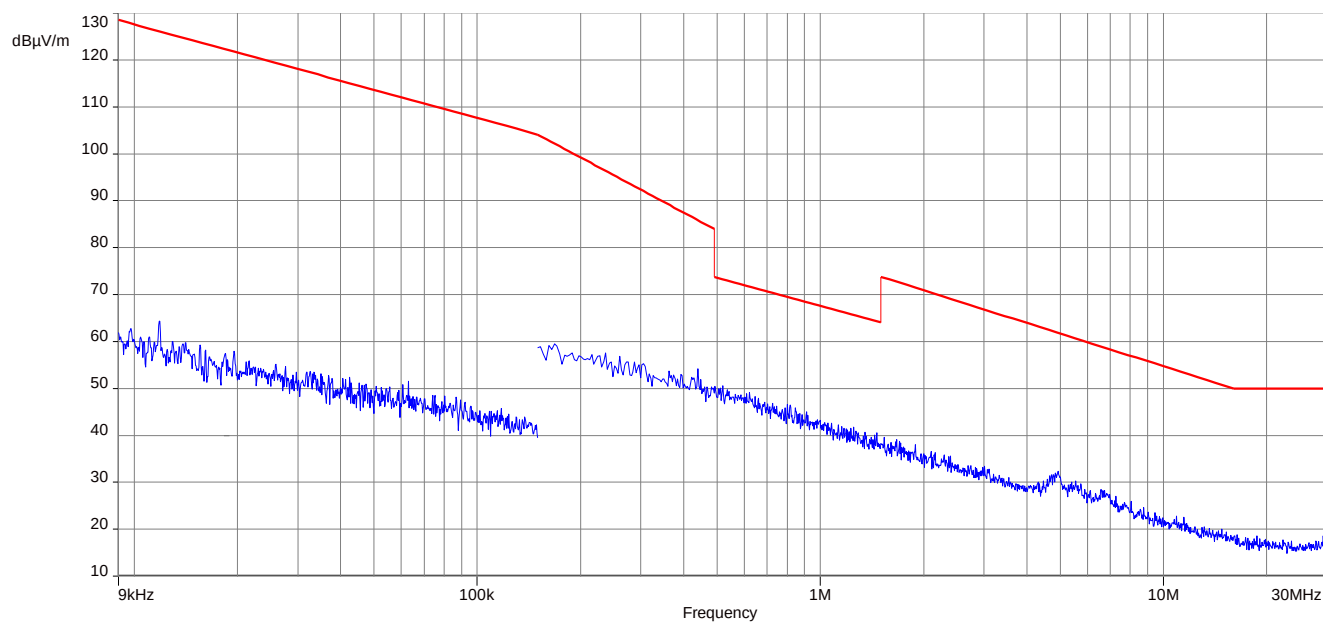
Plot 1: 9 kHz to 30 MHz, channel 00, transmit mode



Plot 2: 9 kHz to 30 MHz, channel 39, transmit mode



Plot 3: 9 kHz to 30 MHz, channel 78, transmit mode



11.11 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	120 kHz
Video bandwidth	3 x RBW
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	☒ GFSK ☐ Pi/4 DQPSK ☐ 8DPSK
Test setup	See sub clause 6.1 A
Measurement uncertainty	See sub clause 8

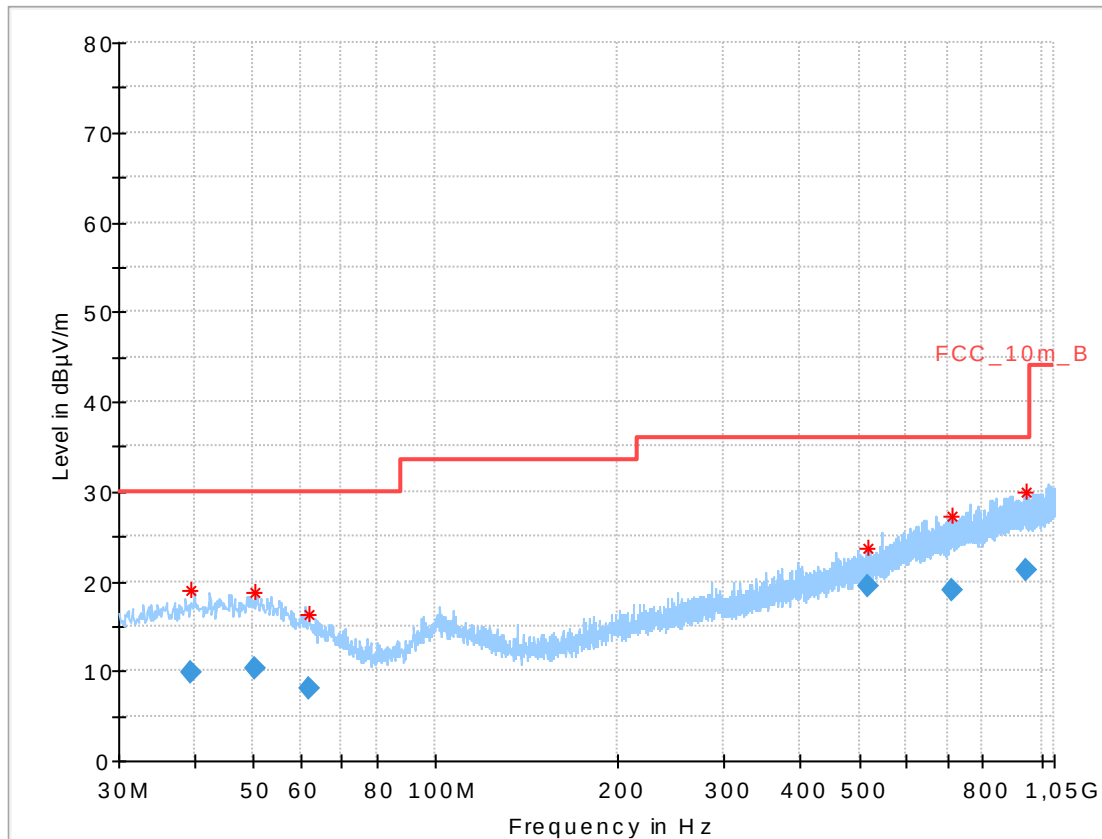
The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dBμV/m)	Measurement distance
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10
Above 960	54.0	3

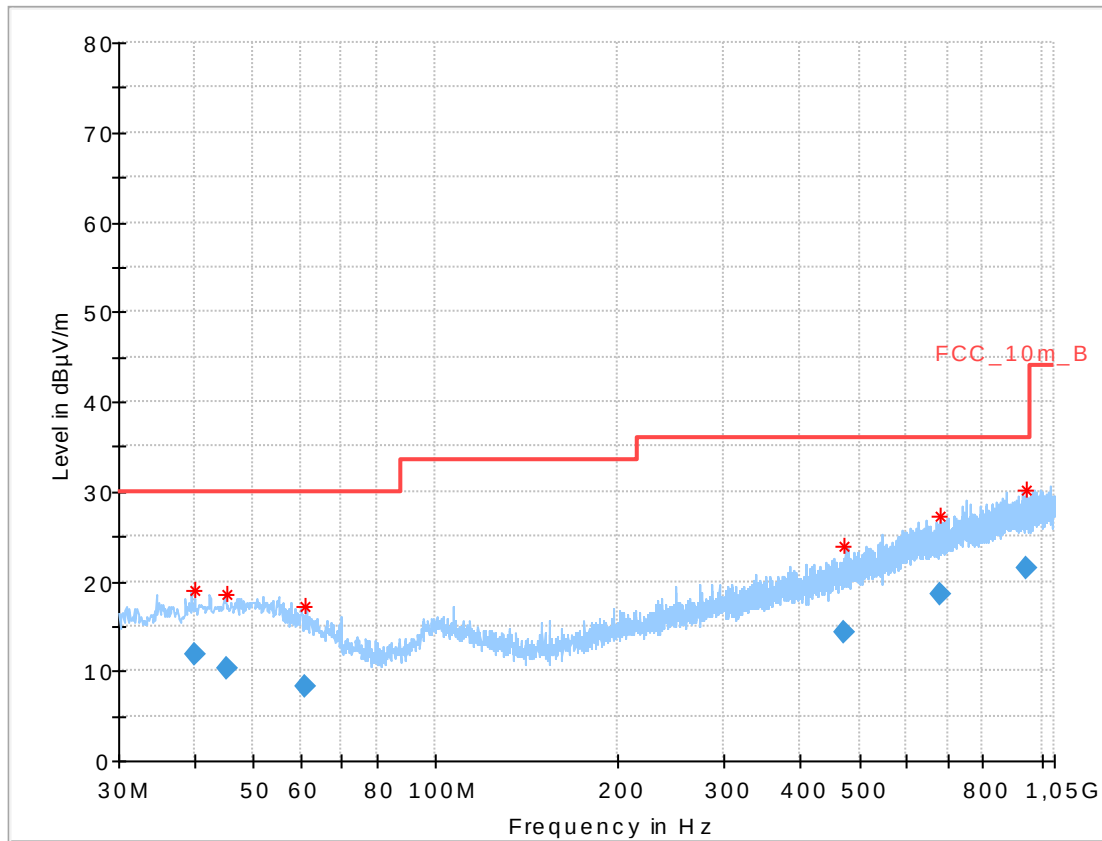
Plots: Transmit mode

Plot 1: 30 MHz to 1 GHz, TX mode, channel 00, vertical & horizontal polarization

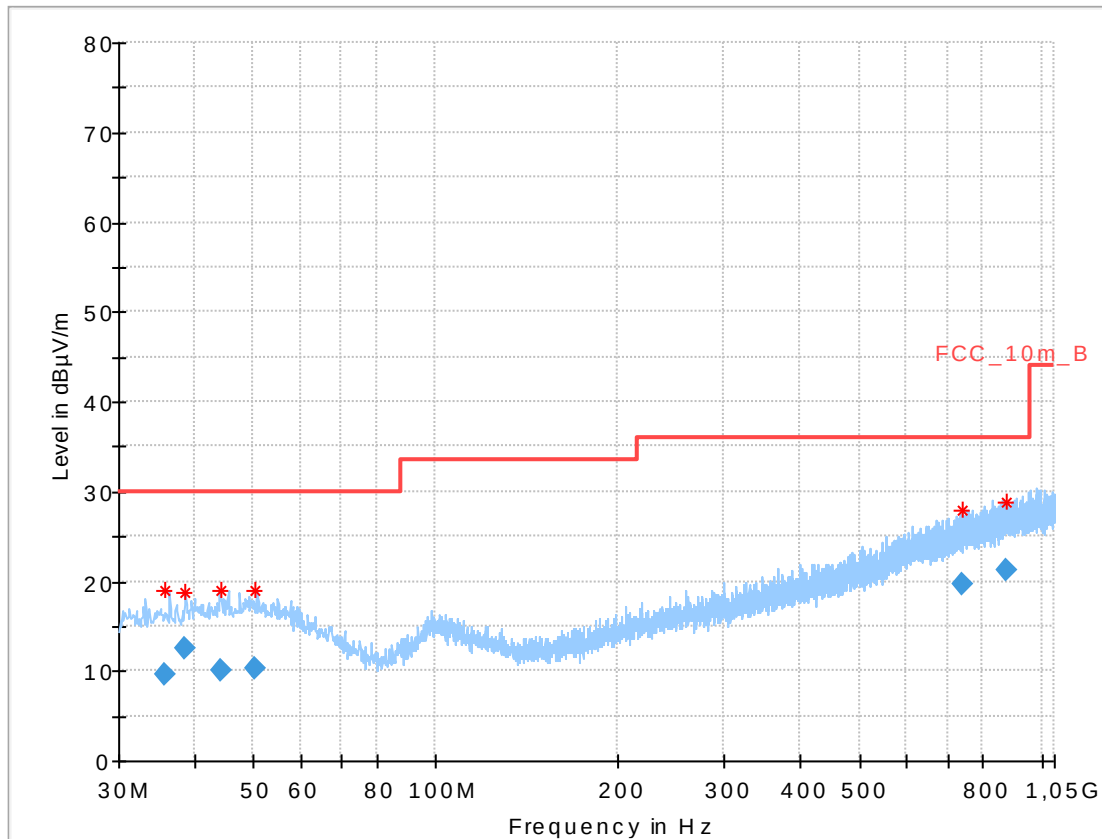


Final results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
39.523050	9.82	30.00	20.18	1000.0	120.000	101.0	V	0.0	13.2
50.357850	10.34	30.00	19.66	1000.0	120.000	98.0	H	165.0	13.7
61.909500	8.04	30.00	21.96	1000.0	120.000	101.0	H	42.0	11.4
515.404050	19.47	36.00	16.53	1000.0	120.000	178.0	V	126.0	18.9
711.019950	19.06	36.00	16.94	1000.0	120.000	179.0	V	195.0	21.8
946.608600	21.32	36.00	14.68	1000.0	120.000	185.0	H	68.0	24.3

Plot 2: 30 MHz to 1 GHz, TX mode, channel 39, vertical & horizontal polarization**Final results:**

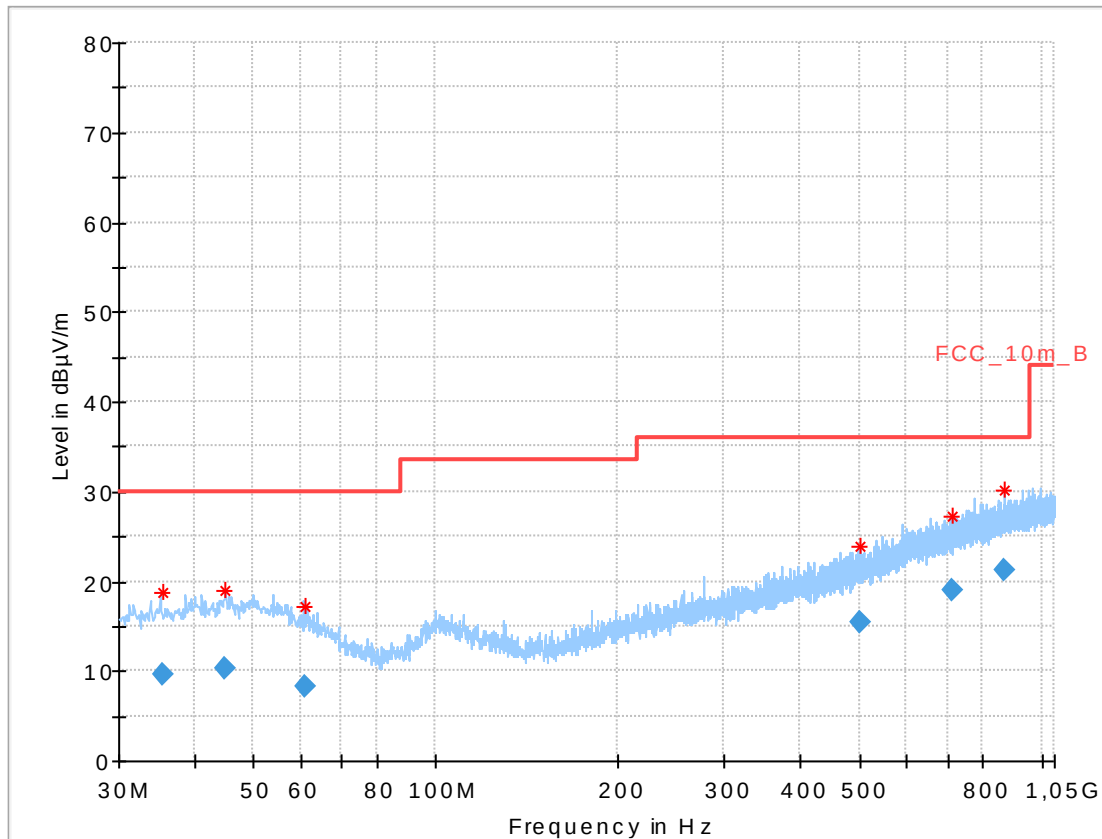
Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
39.973650	11.89	30.00	18.11	1000.0	120.000	101.0	V	328.0	13.2
45.107400	10.28	30.00	19.72	1000.0	120.000	178.0	H	244.0	13.6
60.871050	8.28	30.00	21.72	1000.0	120.000	98.0	H	91.0	11.7
473.705400	14.25	36.00	21.75	1000.0	120.000	101.0	H	51.0	18.2
680.476950	18.56	36.00	17.44	1000.0	120.000	98.0	H	219.0	21.4
944.326050	21.39	36.00	14.61	1000.0	120.000	98.0	H	129.0	24.3

Plot 3: 30 MHz to 1 GHz, TX mode, channel 78, vertical & horizontal polarization**Final results:**

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
35.871750	9.65	30.00	20.35	1000.0	120.000	101.0	V	10.0	12.8
38.715150	12.61	30.00	17.39	1000.0	120.000	170.0	V	81.0	13.1
44.297850	10.06	30.00	19.94	1000.0	120.000	101.0	V	280.0	13.6
50.155950	10.29	30.00	19.71	1000.0	120.000	170.0	H	171.0	13.7
737.325150	19.60	36.00	16.40	1000.0	120.000	98.0	V	280.0	22.4
871.691100	21.20	36.00	14.80	1000.0	120.000	170.0	H	100.0	23.8

Plots: Receiver mode

Plot 1: 30 MHz to 1 GHz, RX / idle – mode, vertical & horizontal polarization



Final results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
35.574450	9.66	30.00	20.34	1000.0	120.000	101.0	V	11.0	12.7
45.068700	10.22	30.00	19.78	1000.0	120.000	101.0	H	68.0	13.6
61.048500	8.34	30.00	21.66	1000.0	120.000	101.0	V	237.0	11.6
500.109750	15.48	36.00	20.52	1000.0	120.000	101.0	V	157.0	18.7
711.409500	19.05	36.00	16.95	1000.0	120.000	179.0	V	112.0	21.8
868.251300	21.17	36.00	14.83	1000.0	120.000	98.0	V	256.0	23.8

11.12 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 26 GHz
Trace mode	Max hold
Measured modulation	☒ GFSK ☐ Pi/4 DQPSK ☐ 8DPSK
Test setup	See sub clause 6.2 A (1 GHz - 18 GHz) See sub clause 6.3 A (18 GHz - 26 GHz)
Measurement uncertainty	See sub clause 8

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dBμV/m)	Measurement distance
Above 960	54.0	3

Results: Transmitter mode

TX spurious emissions radiated [dBµV/m]								
2402 MHz			2441 MHz			2480 MHz		
F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]
12010	Peak	48.7	12205	Peak	51.8	12400	Peak	49.3
	AVG	-/-		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-

*) Average emission adjusting factor:

$$F = 20 * \log (\text{dwell time} / 100 \text{ ms})$$

The dwell time of the longest possible Bluetooth transmission (DH5-packet) is 3.125 ms.

In a period of 100 ms, we have a maximum of 1 transmission and that implies a correction factor for spurious measurement emissions:

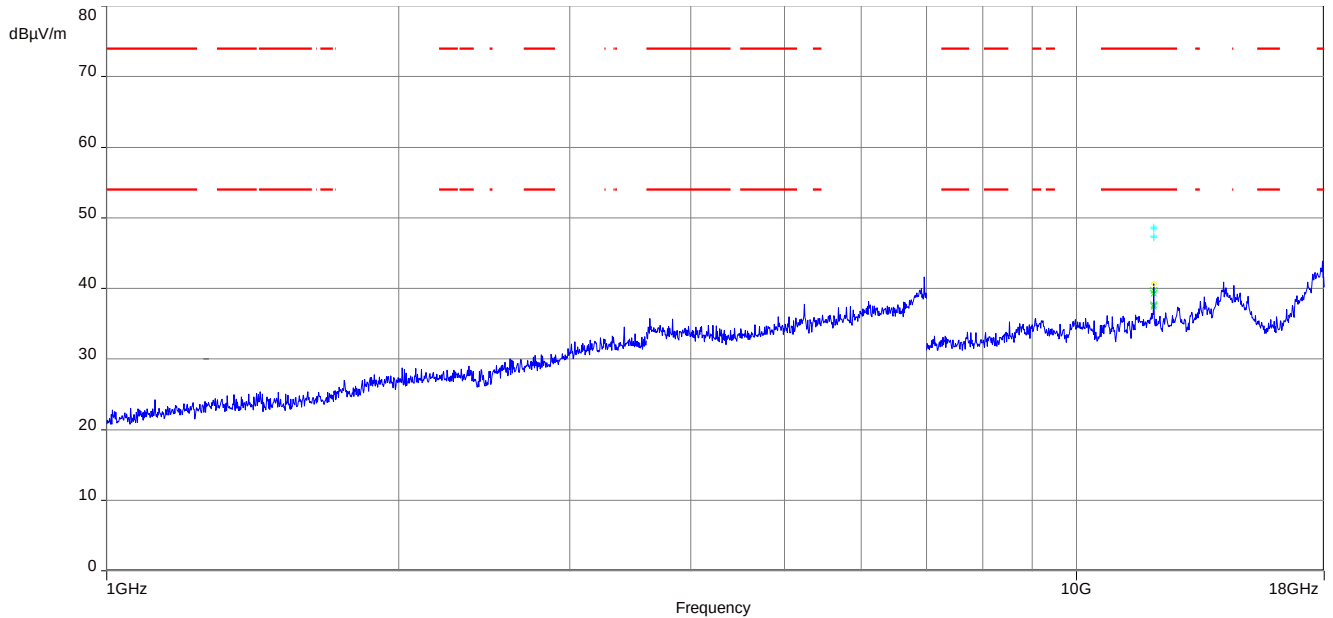
$$F = 20 * \log (1 * 3.125 / 100) = -30.1 \text{ dB}$$

Results: Receiver mode

RX spurious emissions radiated [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
All detected emissions are more than 20 dB below the limit.		
-/-	Peak	-/-
	AVG	-/-

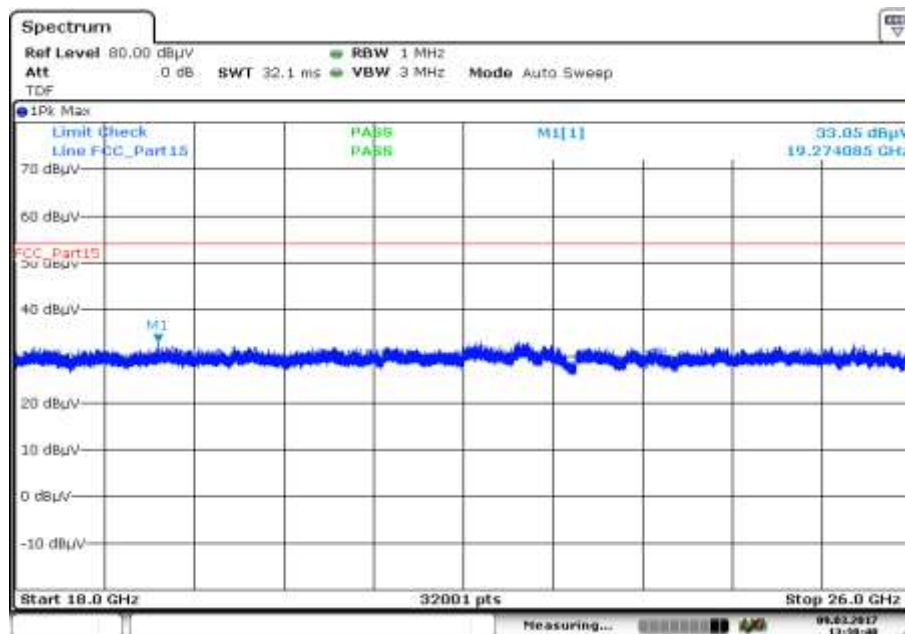
Plots: Transmitter mode

Plot 1: 1 GHz to 18 GHz, TX mode, channel 00, vertical & horizontal polarization



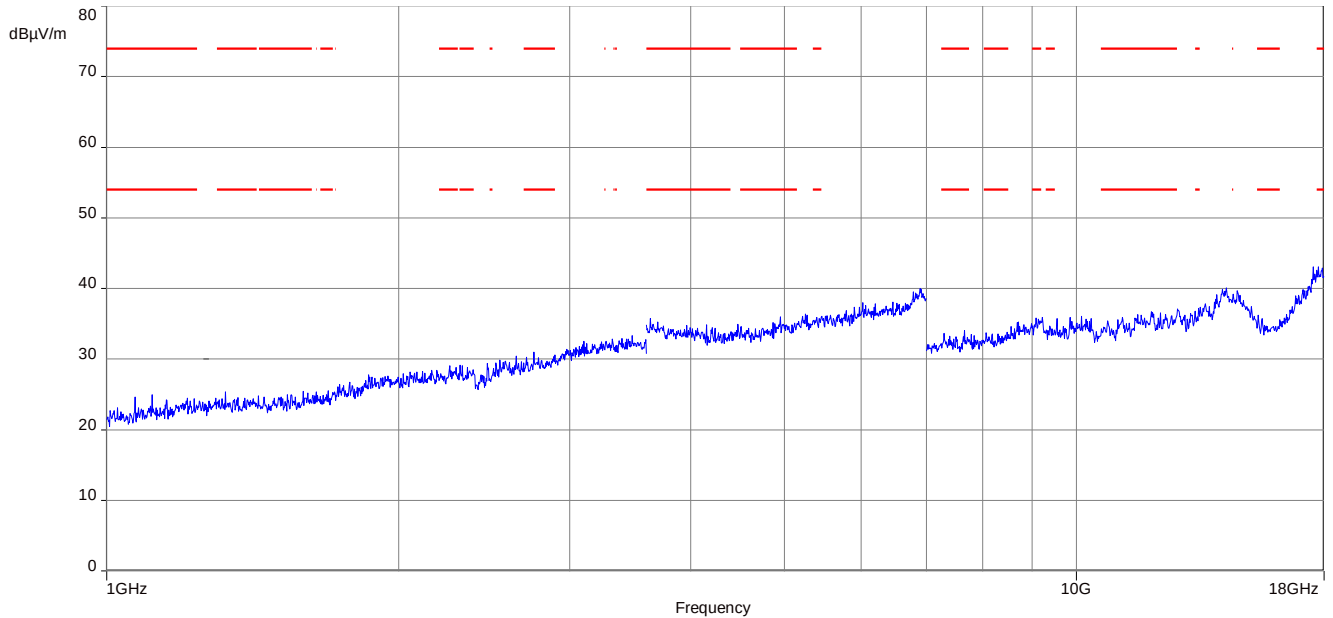
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 2: 18 GHz to 26 GHz, TX mode, channel 00, vertical & horizontal polarization



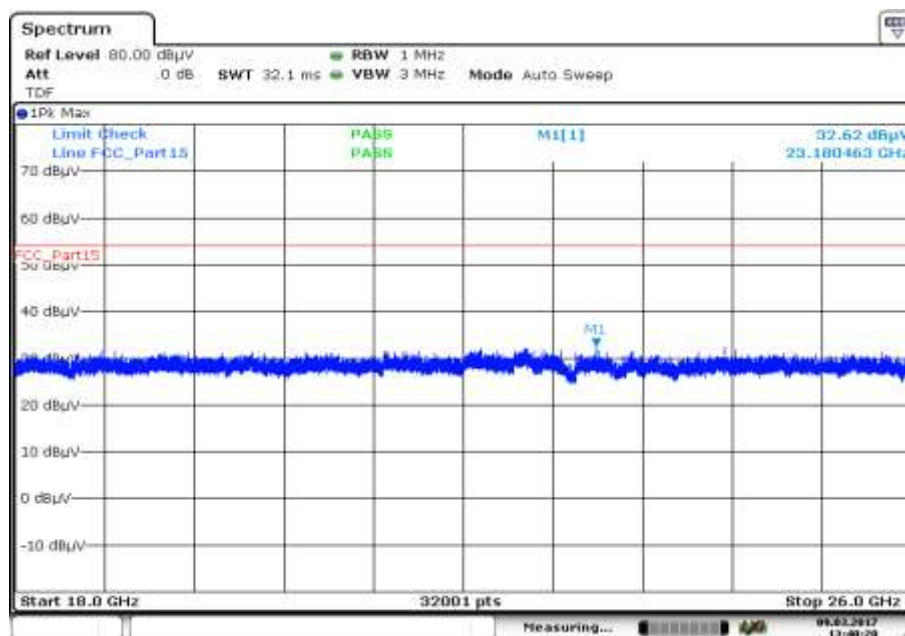
Date: 9.MAR.2017 13:38:48

Plot 3: 1 GHz to 18 GHz, TX mode, channel 39, vertical & horizontal polarization



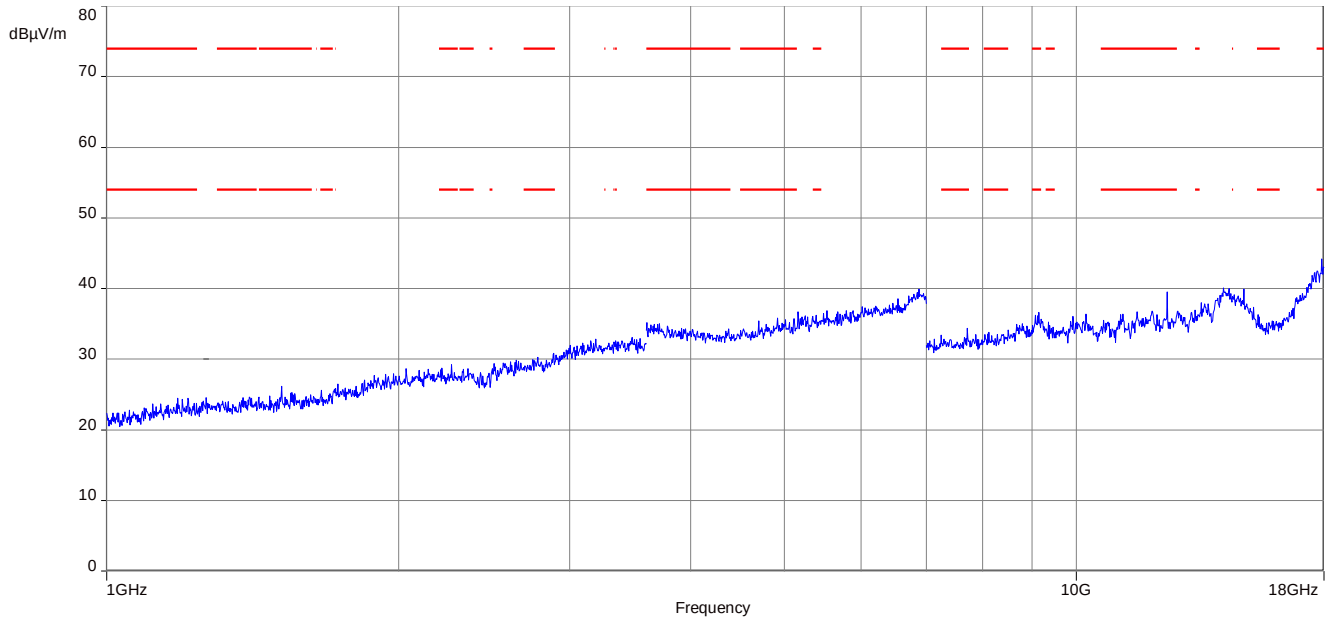
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 4: 18 GHz to 26 GHz, TX mode, channel 39, vertical & horizontal polarization



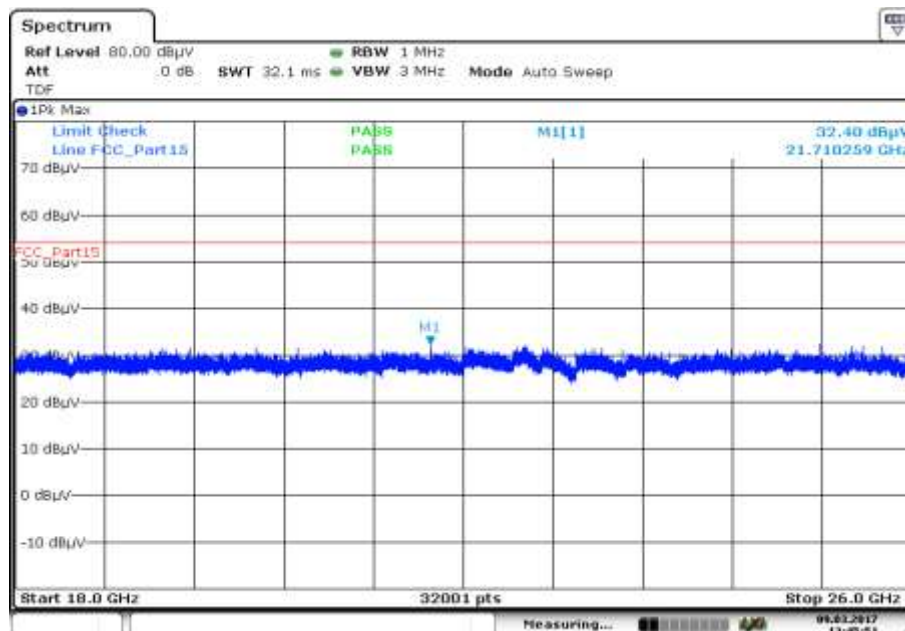
Date: 9.MAR.2017 13:40:21

Plot 5: 1 GHz to 18 GHz, TX mode, channel 78, vertical & horizontal polarization



The carrier signal is notched with a 2.4 GHz band rejection filter.

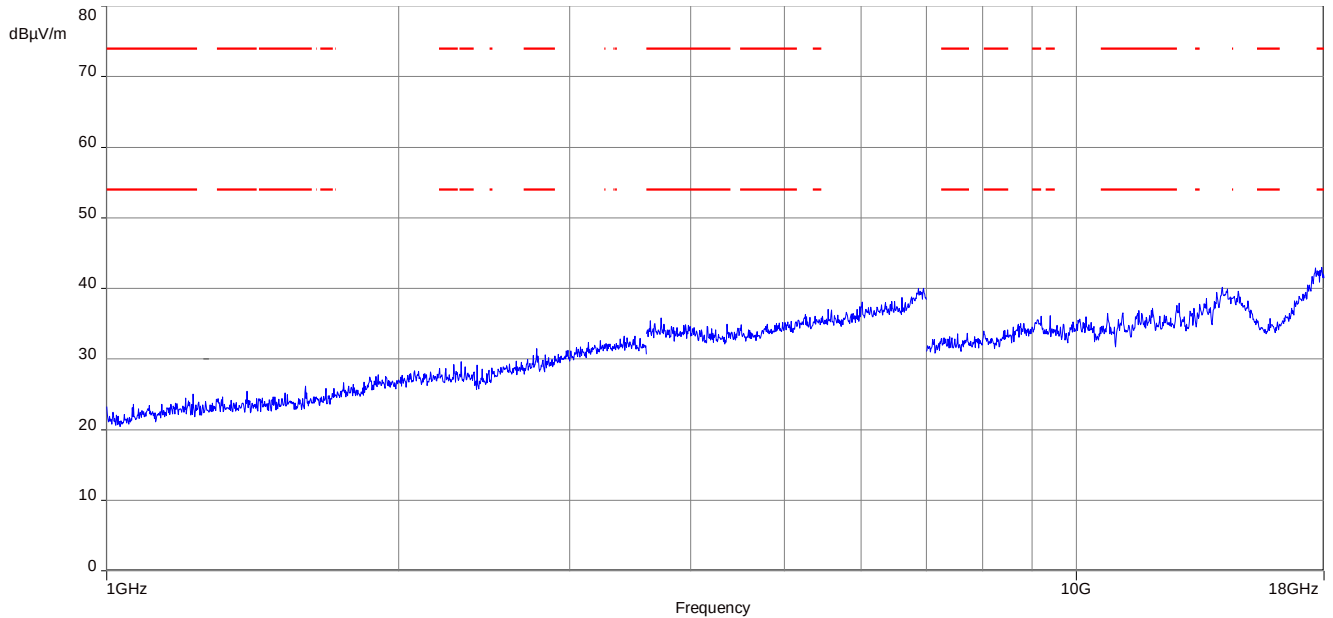
Plot 6: 18 GHz to 26 GHz, TX mode, channel 78, vertical & horizontal polarization



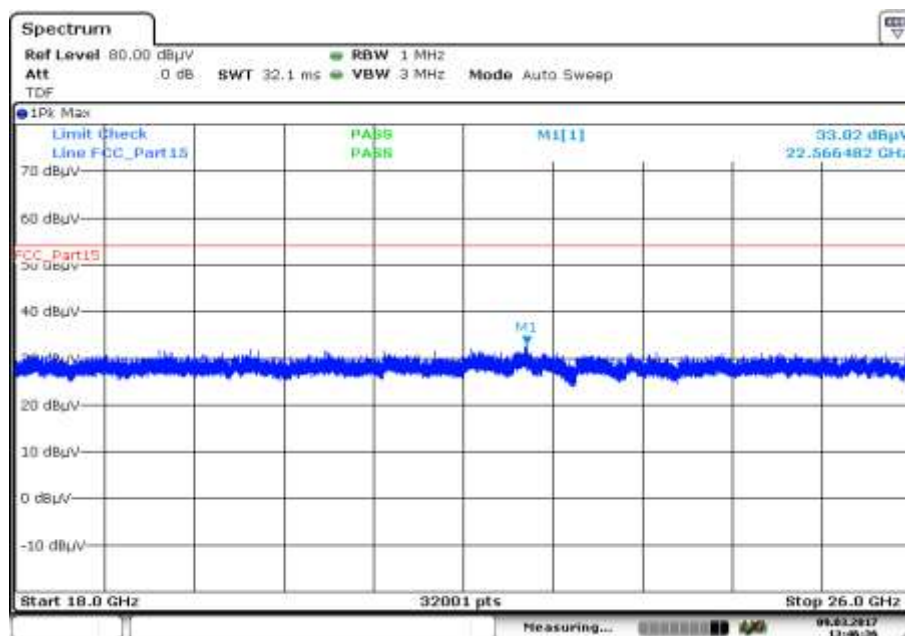
Date: 9.MAR.2017 13:45:51

Plots: Receiver mode

Plot 1: 1 GHz to 18 GHz, RX / idle – mode, vertical & horizontal polarization



Plot 2: 18 GHz to 26 GHz, RX / idle – mode, vertical & horizontal polarization



Date: 9.MAR.2017 13:46:36

12 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2017-04-20

Annex B Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN	-	Product marketing name
HMN	-	Host marketing name
HVIN	-	Hardware version identification number
FVIN	-	Firmware version identification number
OBW		Occupied Bandwidth
OC		Operating Channel
OCW		Operating Channel Bandwidth
OOB		Out Of Band

Annex C Accreditation Certificate

first page

last page



Deutsche Akkreditierungsstelle GmbH

Befähigung gemäß § 9 Absatz 1 AkkStellG i.V.m. § 1 Absatz 1 AkkStellG-BV
 Unterzeichneten der Multilateralen Abkommen
 von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung



Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CTC advanced GmbH
 Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen
 durchzuführen:

Funk
 Mobilfunk (GSM / DCS) + OTA
 Elektromagnetische Verträglichkeit (EMV)
 Produkticherheit
 SAR / EMF
 Umwelt
 Smart Card Technology
 Bluetooth®
 Automotive
 Wi-Fi-Services
 Basissende Anforderungen
 US-Anforderungen
 Aviation
 Near Field Communication (NFC)

Die Akkreditierungsartikelsatz gilt nur in Verbindung mit dem Bescheid vom 25.11.2016. Mit der
 Akkreditierungsnummer 0-PL-12079-01 und ist gültig bis 17.03.2018. Sie besteht aus diesem Deckblatt,
 der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 63 Seiten:

Registrierungsnummer der Urkunde: 0-PL-12079-01-01

Frankfurt, 26.12.2016

Stellvertreterin der DAkkS

Im Auftrag der DAkkS, Dr. Kai Tietze
 Akkreditierungsleiter

Deutsche Akkreditierungsstelle GmbH

Standort Berlin
 Schlossmarkt 10
 10117 Berlin

Standort Frankfurt am Main
 Europa-Ring 53
 60527 Frankfurt am Main

Standort Braunschweig
 Bundesallee 100
 38116 Braunschweig

Die ausschließliche Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen
 Zustimmung der Deutschen Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate
 Weiterverbreitung des Deckblatts durch die ursprünglich geneigte Akkreditierungsstelle in
 unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt,
 die über den durch die DAkkS festgelegten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgt gemäß des Gesetzes über die Akkreditierungsstelle (AkkStellG) vom
 11. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EU) Nr. 765/2008 des Europäischen Parlaments
 und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und die Nachprüfung
 in Zusammenhang mit der Vermarktung von Produkten (AM, L 218 vom 9. Juli 2008, S. 30).
 Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der
 European Conformity Assessment (EAC), des International Accreditation Forum (IAF) und
 der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen
 erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
 EA: www.euroconform-accrreditation.org
 IAF: www.iaf.org
 ILAC: www.ilac.org

Note:

The current certificate including annex can be received on request.